

# FCC Part 15 EMI TEST REPORT of

E.U.T. : Bluetooth Headset

MODEL : 50235

FCC ID. : O3OCCM03

for

APPLICANT : Topcell Technology Co., Ltd.

ADDRESS : No. 403, Jung Min Road, Chungli, Taoyuan Hsien,  
Taiwan, R.O.C.

Test Performed by

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Report Number : ET92R-09-064

# TEST REPORT CERTIFICATION

Applicant : Topcell Technology Co., Ltd.  
No. 403, Jung Min Road, Chungli, Taoyuan Hsien, Taiwan, R.O.C.

Manufacturer : Topcell Technology Co., Ltd.  
No. 403, Jung Min Road, Chungli, Taoyuan Hsien, Taiwan, R.O.C.

Description of EUT :

a) Type of EUT : Bluetooth Headset

b) Trade Name : ----

c) Model No. : 50235

d) Power Supply : 3.6Vdc

Regulation Applied : FCC Rules and Regulations Part 15 Subpart B & C (2002)

I HEREBY CERTIFY THAT: The data shown in this report were made in accordance with the procedures given in ANSI C63.4, and the energy emitted by the device was founded to be within the limits applicable. I assume full responsibility for accuracy and completeness of these data.

Note: 1. The result of the testing report relates only to the item tested.  
2. The testing report shall not be reproduced expect in full, without the written approval of ETC.

Issued Date : Oct. 15, 2003

Test Engineer : Tien Lu Liao  
( Tien Lu Liao )

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# 1 GENERAL INFORMATION

## 1.1 Product Description

- a) Type of EUT : Bluetooth Headset
- b) Trade Name : ----
- c) Model No. : 50235
- d) Power Supply : 3.6Vdc

## 1.2 Characteristics of Device

The EUT is a wireless headset for Bluetooth cellphone which works in ISM band 2.402GHz to 2.480GHz.

## 1.3 Test Methodology

For Bluetooth Headset, both conducted and radiated emissions were performed according to the procedures illustrated in ANSI C63.4 (1992) and for processing gain measurement is according to FCC Public Notice. Other required measurements were illustrated in separate sections of this test report for details.

## 1.4 Test Facility

The open area test site and conducted measurement facility used to collect the radiated data is located on the roof top of Building at No.34, Lin 5, Ding Fu Tsun, Linkou Hsiang, Taipei Hsien, Taiwan, R.O.C.

This site has been fully described in a report submitted to your office, and accepted in a letter dated Feb. 10, 2000.

## 2 PROVISIONS APPLICABLE

### 2.1 Definition

**Unintentional radiator:**

A device that intentionally generates and radio frequency energy for use within the device, or that sends radio frequency signals by conduction to associated equipment via connecting wiring, but which is not intended to emit RF energy by radiation or induction.

**Class A Digital Device:**

A digital device which is marketed for use in commercial or business environment; exclusive of a device which is market for use by the general public, or which is intended to be used in the home.

**Class B Digital Device :**

A digital device which is marketed for use in a residential environment notwithstanding use in a commercial, business or industrial environment. Example of such devices that are marketed for the general public.

Note : A manufacturer may also qualify a device intended to be marketed in a commercial, business, or industrial environment as a Class B digital device, and in fact is encouraged to do so, provided the device complies with the technical specifications for a Class B Digital Device. In the event that a particular type of device has been found to repeatedly cause harmful interference to radio communications, the Commission may classify such a digital device as a Class B Digital Device, Regardless of its intended use.

**Intentional radiator:**

A device that intentionally generates and emits radio frequency energy by radiation or induction.

## 2.2 Requirement for Compliance

### (1) Conducted Emission Requirement

Except as shown in paragraphs (b) and (c) of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies within the band 150kHz to 30 MHz shall not exceed the limits in the following table, as measured using a 50 $\Omega$ /50 ohms line impedance stabilization network (LISN). Compliance with the provisions of this paragraph shall be based on the measurement of the radio frequency voltage between each power line and ground at the power terminal. The lower limit applies at the boundary between the frequency ranges.

Frequency MHz	Quasi Peak dB $\mu$ V	Average dB $\mu$ V
0.15 - 0.5	66-56*	56-46*
0.5 - 5.0	56	46
5.0 - 30.0	60	50

\* Decreases with the logarithm of the frequency

For intentional device, according to § 15.207(a) Line Conducted Emission Limits is same as above table.

### (2) Radiated Emission Requirement

For unintentional device, according to § 15.109(a), except for Class A digital devices, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency MHz	Distance Meters	Radiated dB $\mu$ V/m	Radiated $\mu$ V/m
30 - 88	3	40.0	100
88 - 216	3	43.5	150
216 - 960	3	46.0	200
Above 960	3	54.0	500

For intentional device, according to § 15.209(a), the general requirement of field strength of radiated emissions from intentional radiators at a distance of 3 meters shall not exceed the above table.



**(3) Antenna Requirement**

For intentional device, according to § 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

**(4) Hopping Channel Separation**

According to 15.247(a)(1), frequency hopping system shall have , hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater.

**(5) Number of Hopping frequencies used**

According to 15.247(a)(1)(iii), frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 non-overlapping channels.

**(6) Hopping Channel Bandwidth**

According to 15.247(a)(1)(ii), for frequency hopping system operating in the 5725-5850 MHz band, the maximum 20dB bandwidth of the hopping channel is 1MHz.

**(7) Dwell Time of each frequency within a 30-second period**

According to 15.247(a)(1)(iii), for frequency hopping system operating in the 2400-2483.5 MHz band, the average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

**(8) Output Power Requirement**

According to 15.247(b)(1), for frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt.

For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.

**(9) 100 kHz Bandwidth of Frequency Band Edges Requirement**

According to 15.247(c), in any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required.

**(10) Out-of-Band Conducted Emission Requirement**

According to 15.247(c), in any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required.

**(11) Peak Power Spectral Density Requirement**

According to 15.247(d), for digitally modulated systems, the peak power spectral density conducted from the intentional radiator to the antenna shall not be greater than 8 dBm in any 3 kHz band during any time interval of continuous transmission.

**2.3 Restricted Bands of Operation**

Only spurious emissions are permitted in any of the frequency bands listed below :

MHz	MHz	MHz	GHz
0.090 - 0.110	16.42-16.423	399.9-410	4.5-5.15
0.495 - 0.505 **	16.69475 - 16.69525	608-614	5.35-5.46
2.1735 - 2.1905	16.80425 - 16.80475	960-1240	7.25-7.75
4.125-4.128	25.5-25.67	1300-1427	8.025-8.5
4.17725-4.17775	37.5-38.25	1435-1626.5	9.0-9.2
4.20725-4.20775	73-74.6	1645.5-1646.5	9.3-9.5
6.215-6.218	74.8-75.2	1660-1710	10.6-12.7
6.26775-6.26825	108-121.94	1718.8-1722.2	13.25-13.4
6.31175-6.31225	123-138	2200-2300	14.47-14.5
8.291-8.294	149.9-150.05	2310-2390	15.35-16.2
8.362-8.366	156.52475 - 156.52525	2483.5-2500	17.7-21.4
8.37625-8.38675	156.7-156.9	2655-2900	22.01-23.12
8.41425-8.41475	162.0125-167.17	3260-3267	23.6-24.0
12.29-12.293	167.72-173.2	3332-3339	31.2-31.8
12.51975-12.52025	240-285	3345.8-3358	36.43-36.5
12.57675-12.57725	322-335.4	3360-4400	Above 38.6
13.36-13.41			

\*\* : Until February 1, 1999, this restricted band shall be 0.490-0.510 MHz

## 2.4 Labeling Requirement

The device shall bear the following statement in a conspicuous location on the device :

This device complies with part 15 of the FCC Rules. Operation is subject to the following two conditions : (1) This device may not cause harmful interference, and (2) this device must accept any interference received, including interference that may cause undesired operation.

## 2.5 User Information

The users manual or instruction manual for an intentional or unintentional radiator shall caution the user that changes or modifications not expressly approved by the party responsible for compliance could void the user's authority to operate the equipment.

For a Class B digital device or peripheral, the instructions furnished the user shall include the following or similar statement, placed in a prominent location in the text of the manual.

The Federal Communications Commission Radio Frequency Interference Statement includes the following paragraph.

This equipment has been tested and found to comply with the limits for a Class B Digital Device, pursuant to Part 15 of the FCC Rules. These limits are designed to provide reasonable protection against harmful interference in a residential installation.

This equipment generates, uses and can radiate radio frequency energy and, if not installed and used in accordance with the instruction may cause harmful interference to radio communication. However, there is no guarantee that interference will not occur in a particular installation.

If this equipment does cause harmful interference to radio or television reception, which can be determined by turning the equipment off and on, the user is encouraged to try to correct the interference by one or more of the following measures:

- Reorient or relocate the receiving antenna.
- Increase the separation between the equipment and receiver.
- Connect the equipment into an outlet on a circuit different from that to which the receiver is connected.
- Consult the dealer or an experienced radio / TV technician for help.

### 3. SYSTEM TEST CONFIGURATION

#### 3.1 Justification

For both radiated and conducted emissions below 1 GHz, the system was configured for testing in a typical fashion as a customer would normally use it. The peripherals other than EUT were connected in normally standing by situation. Measurement was performed under the condition that a computer program was exercised to simulate data communication of EUT, and the transmission rate was set to maximum allowed by EUT. Three highest emissions were verified with varying placement of the transmitting antenna connected to EUT to maximize the emission from EUT.

For conducted emissions, only measured on TX and RX operation, for the digital circuits portion also function normally whenever TX or RX is operated. For radiated emissions, whichever RF channel is operated, the digital circuits' function identically. As the reason, measurement of radiated emissions from digital circuits is only performed with channel 11 by transmitting mode.

#### 3.2 Devices for Tested System

Device	Manufacture	Model / FCC ID.	Cable Description
Bluetooth Headset *	Topcell Technology Co., Ltd.	50235 /O3OCCM03	----
Power Supply	GM	----	1.8m Unshielded AC Power Cord
Notebook	ASUS	L1400	1.2m RS-232 Unshielded Cable 0.5m Unshielded Cable 2.5m Unshielded AC Adaptor Power Cord

Remark “\*” means equipment under test.

## 4 RADIATED EMISSION MEASUREMENT

### 4.1 Applicable Standard

For unintentional radiator, the radiated emission shall comply with § 15.109(a).

For intentional radiators, according to § 15.247 (a), operation under this provision is limited to frequency hopping and direct sequence spread spectrum, and the out band emission shall be comply with § 15.247 (c)

### 4.2 Measurement Procedure

1. Setup the configuration per figure 1 and 2 for frequencies measured below and above 1 GHz respectively.
2. For emission frequencies measured below 1 GHz, a pre-scan is performed in a shielded chamber to determine the accurate frequencies of higher emissions will be checked on a open test site. As the same purpose, for emission frequencies measured above 1 GHz, a pre-scan also be performed with a 1 meter measuring distance before final test.
3. For emission frequencies measured below and above 1 GHz, set the spectrum analyzer on a 100 kHz and 1 MHz resolution bandwidth respectively for each frequency measured in step 2.
4. The search antenna is to be raised and lowered over a range from 1 to 4 meters in horizontally polarized orientation. Position the highness when the highest value is indicated on spectrum analyzer, then change the orientation of EUT on test table over a range from 0 ° to 360 ° with a speed as slow as possible, and keep the azimuth that highest emission is indicated on the spectrum analyzer. Vary the antenna position again and record the highest value as a final reading. A RF test receiver is also used to confirm emissions measured.

Note : A band pass filter was used to avoid pre-amplifier saturated when measure TX operation mode in frequency band above 1 GHz.

5. Repeat step 4 until all frequencies need to be measured were complete.
6. Repeat step 5 with search antenna in vertical polarized orientations.
7. Check the three frequencies of highest emission with varying the placement of cables associated with EUT to obtain the worse case and record the result.

Figure 1 : Frequencies measured below 1 GHz configuration

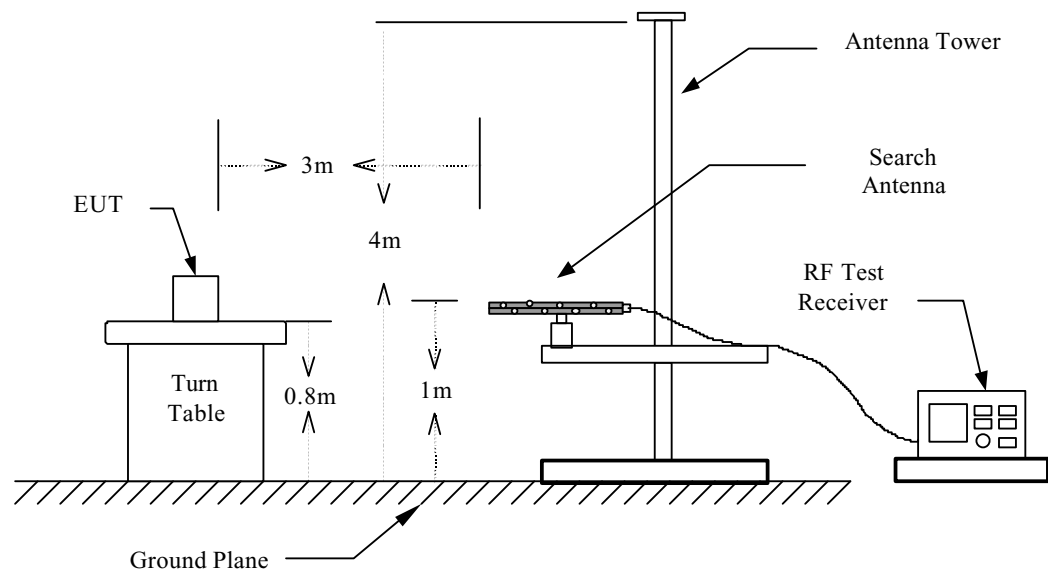
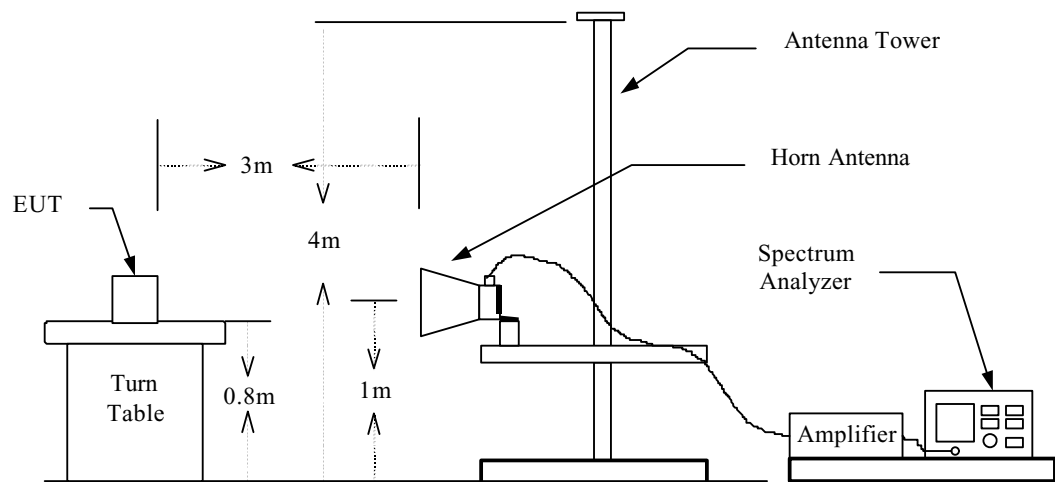


Figure 2 : Frequencies measured above 1 GHz configuration



### 4.3 Measuring Instrument

The following instrument are used for radiated emissions measurement:

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8568B	01/09/2004
Pre-selector	Hewlett-Packard	85685A	01/09/2004
Quasi Peak Detector	Hewlett-Packard	85650A	01/09/2004
RF Test Receiver	Rohde & Schwarz	ESVS 30	08/05/2004
RF Test Receiver	Rohde & Schwarz	ESBI	05/15/2004
Horn Antenna	EMCO	3115	05/15/2004
Log periodic Antenna	EMCO	3146	11/04/2003
Biconical Antenna	EMCO	3110B	11/04/2003
Preamplifier	Hewlett-Packard	8449B	05/29/2004
Preamplifier	Hewlett-Packard	8447D	09/28/2004
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2004

Measuring instrument setup in measured frequency band when specified detector function is used :

Frequency Band (MHz)	Instrument	Function	Resolution bandwidth	Video Bandwidth
30 to 1000	RF Test Receiver	Quasi-Peak	120 kHz	N/A
	Spectrum Analyzer	Peak	100 kHz	100 kHz
Above 1000	Spectrum Analyzer	Peak	1 MHz	1 MHz
	Spectrum Analyzer	Average	1 MHz	10 Hz

## 4.4 Radiated Emission Data

### 4.4.1 Fundatmental and Harmonics

Operation Mode : TX/RX

Fundamental Frequency : 2402 MHz ( Local Frequency : 2400.502 MHz )

Test Date : Sep. 25, 2003

Temperature : 24 °C

Humidity : 62 %

Frequency  (MHz)	Reading (dBuV)				Factor (dB)  Corr.	Result @3m (dBuV/m)		Limit @3m (dBuV/m)		Margin (dB)	Table Deg. (Deg.)	Ant. High (m)
	H		V			Peak	Ave	Peak	Ave.			
	Peak	Ave	Peak	Ave								
*2400.502	51.0	40.3	57.7	51.8	-3.1	54.6	48.7	74.0	54.0	-5.3	180	1.0
*4801.004	---	---	---	---	2.5	---	---	74.0	54.0	---	---	---
*7201.506	---	---	---	---	5.7	---	---	74.0	54.0	---	---	---
*9602.008	---	---	---	---	7.2	---	---	74.0	54.0	---	---	---
*12002.510	---	---	---	---	9.2	---	---	74.0	54.0	---	---	---
4804.000	---	---	---	---	2.5	---	---	74.0	54.0	---	---	---
7206.000	---	---	---	---	5.7	---	---	74.0	54.0	---	---	---
9608.000	---	---	---	---	7.2	---	---	74.0	54.0	---	---	---
12010.000	---	---	---	---	9.2	---	---	74.0	54.0	---	---	---
14412.000	---	---	---	---	11.5	---	---	74.0	54.0	---	---	---
16814.000	---	---	---	---	11.8	---	---	74.0	54.0	---	---	---
19216.000	---	---	---	---	8.9	---	---	74.0	54.0	---	---	---
21618.000	---	---	---	---	9.7	---	---	74.0	54.0	---	---	---
24020.000	---	---	---	---	10.3	---	---	74.0	54.0	---	---	---

Note :

1. Remark “\*” means local oscillation frequency.
2. The receiving local oscillation frequency and the harmonics are too low to be measured.
3. Remark “---” means that the emission level is too low to be measured (a pre-amplifier of about 35 dB is used).
4. Margins are derived from Peak or Average whichever is lower. If there is only peak value in Result field, the Margin is also referred to average limits.
5. The expanded uncertainty of the radiated emission tests is 3.53 dB.



Operation Mode : TX/RX

Fundamental Frequency : 2441 MHz ( Local Frequency : 2439.503 MHz )

Test Date : Sep. 25, 2003

Temperature : 24 °C

Humidity : 62 %

Frequency  (MHz)	Reading (dBuV)				Factor (dB)  Corr.	Result @3m (dBuV/m)		Limit @3m (dBuV/m)		Margin (dB)	Table Deg. (Deg.)	Ant. High (m)
	H		V			Peak	Ave	Peak	Ave.			
	Peak	Ave	Peak	Ave								
*2439.503	49.7	43.7	58.2	52.7	-2.9	55.3	49.8	74.0	54.0	-4.2	175	1.0
*4879.006	---	---	---	---	2.7	---	---	74.0	54.0	---	---	---
*7318.509	---	---	---	---	5.9	---	---	74.0	54.0	---	---	---
*9758.012	---	---	---	---	7.3	---	---	74.0	54.0	---	---	---
*12197.515	---	---	---	---	9.3	---	---	74.0	54.0	---	---	---
4882.000	---	---	---	---	2.7	---	---	74.0	54.0	---	---	---
7323.000	---	---	---	---	5.9	---	---	74.0	54.0	---	---	---
9764.000	---	---	---	---	7.3	---	---	74.0	54.0	---	---	---
12205.000	---	---	---	---	9.3	---	---	74.0	54.0	---	---	---
14646.000	---	---	---	---	11.6	---	---	74.0	54.0	---	---	---
17087.000	---	---	---	---	13.3	---	---	74.0	54.0	---	---	---
19528.000	---	---	---	---	8.5	---	---	74.0	54.0	---	---	---
21969.000	---	---	---	---	9.9	---	---	74.0	54.0	---	---	---
24410.000	---	---	---	---	10.7	---	---	74.0	54.0	---	---	---

Note :

1. Remark "\*" means local oscillation frequency.
2. The receiving local oscillation frequency and the harmonics are too low to be measured.
3. Remark "---" means that the emission level is too low to be measured (a pre-amplifier of about 35 dB is used).
4. Margins are derived from Peak or Average whichever is lower. If there is only peak value in Result field, the Margin is also referred to average limits.
5. The expanded uncertainty of the radiated emission tests is 3.53 dB.

Operation Mode : TX/RX

Fundamental Frequency : 2480 MHz ( Local Frequency : 2478.510 MHz )

Test Date : Sep. 25, 2003

Temperature : 24 °C

Humidity : 62 %

Frequency  (MHz)	Reading (dBuV)				Factor (dB)  Corr.	Result @3m (dBuV/m)		Limit @3m (dBuV/m)		Margin (dB)	Table Deg. (Deg.)	Ant. High (m)
	H		V			Peak	Ave	Peak	Ave.			
	Peak	Ave	Peak	Ave								
*2478.510	50.2	42.8	57.0	53.0	-2.8	54.2	50.2	74.0	54.0	-3.8	185	1.0
*4957.020	---	---	---	---	2.8	---	---	74.0	54.0	---	---	---
*7435.530	---	---	---	---	6.1	---	---	74.0	54.0	---	---	---
*9914.040	---	---	---	---	7.4	---	---	74.0	54.0	---	---	---
*12392.550	---	---	---	---	9.4	---	---	74.0	54.0	---	---	---
4960.000	---	---	---	---	2.8	---	---	74.0	54.0	---	---	---
7440.000	---	---	---	---	6.1	---	---	74.0	54.0	---	---	---
9920.000	---	---	---	---	7.4	---	---	74.0	54.0	---	---	---
12400.000	---	---	---	---	9.4	---	---	74.0	54.0	---	---	---
14880.000	---	---	---	---	11.5	---	---	74.0	54.0	---	---	---
17360.000	---	---	---	---	15.2	---	---	74.0	54.0	---	---	---
19840.000	---	---	---	---	8.6	---	---	74.0	54.0	---	---	---
22320.000	---	---	---	---	10.2	---	---	74.0	54.0	---	---	---
24800.000	---	---	---	---	11.0	---	---	74.0	54.0	---	---	---

Note :

1. Remark “\*” means local oscillation frequency.
2. The receiving local oscillation frequency and the harmonics are too low to be measured.
3. Remark “---” means that the emission level is too low to be measured (a pre-amplifier of about 35 dB is used).
4. Margins are derived from Peak or Average whichever is lower. If there is only peak value in Result field, the Margin is also referred to average limits.
5. The expanded uncertainty of the radiated emission tests is 3.53 dB.

**4.4.2 Radiated Emissions in Restricted Bands**

Test Date : Sep. 25, 2003

Temperature : 24 °C

Humidity : 62 %

**Operation Mode : TX : 2402 MHz Restricted Frequency band : 2310MHz-2390MHz**

Frequency  (MHz)	Reading (dBuV)				Factor (dB)  Corr.	Result @3m (dBuV/m) Peak      Ave		Limit @3m (dBuV/m) Peak      Ave.		Margin (dB)	Table Deg. (Deg.)	Ant. High (m)
	H		V			Peak	Ave	Peak	Ave.			
	Peak	Ave	Peak	Ave								
2317.581	40.7	---	38.5	---	-3.2	37.5	---	74.0	54.0	-36.5	180	1.0
2385.671	41.3	---	39.3	---	-3.2	38.1	---	74.0	54.0	-35.9	200	1.2

**Operation Mode : TX : 2480 MHz Restricted Frequency band : 2483.5MHz-2500MHz**

Frequency  (MHz)	Reading (dBuV)				Factor (dB)  Corr.	Result @3m (dBuV/m) Peak      Ave		Limit @3m (dBuV/m) Peak      Ave.		Margin (dB)	Table Deg. (Deg.)	Ant. High (m)
	H		V			Peak	Ave	Peak	Ave.			
	Peak	Ave	Peak	Ave								
2489.751	41.8	---	39.7	---	-2.7	39.1	---	74.0	54.0	-34.9	180	1.0
2493.751	42.3	---	40.3	---	-2.7	39.6	---	74.0	54.0	-34.4	200	1.2

**Note :**

1. Remark “---” means that the emissions level is too low to be measured.
2. The expanded uncertainty of the radiated emission tests is 3.53 dB.

#### 4.4.3 Other Emissions

a) Emission frequencies below 1 GHz

Operation Mode : TX/RX

Test Date : Sep. 25, 2003

Temperature : 24 °C

Humidity : 62 %

Frequency (MHz)	Ant-Pol H/V	Meter Reading (dBuV)	Corrected Factor (dB)	Result @3m (dBuV/m)	Limit @3m (dBuV/m)	Margin (dB)	Table Degree (Deg.)	Ant. High (m)
120.720	H	48.9	-10.9	38.0	43.5	-5.5	0	4.0
144.750	H	43.8	-10.4	33.4	43.5	-10.1	180	4.0
168.780	H	43.9	-9.1	34.8	43.5	-8.7	270	4.0
192.810	H	49.2	-8.0	41.2	43.5	-2.3	90	4.0
367.900	H	42.8	-7.2	35.6	46.0	-10.4	180	4.0
433.700	H	41.9	-5.5	36.4	46.0	-9.6	90	4.0

b) Emission frequencies above 1 GHz

Radiated emission frequencies above 1 GHz to 25 GHz were too low to be measured with a pre-amplifier of 35 dB.

#### 4.5 Field Strength Calculation

The field strength is calculated by adding the Antenna Factor, High Pass Filter Loss (if used) and Cable Loss, and subtracting the Amplifier Gain (if any) from the measured reading. The basic equation calculation is as follows:

$$\text{Result} = \text{Reading} + \text{Corrected Factor}$$

where

$$\text{Corrected Factor} = \text{Antenna FACTOR} + \text{Cable Loss} + \text{High Pass Filter Loss} - \text{Amplifier Gain}$$

## **4.6 Photos of Radiation Measuring Setup**

Please See Exhibits\_ Test Setup Photos

## **5 CONDUCTED EMISSION MEASUREMENT**

### **5.1 Standard Applicable**

This EUT is excused from investigation of conducted emission, for it is powered by battery only. According to § 15.207 (c), measurements to demonstrate compliance with the conducted limits are not required for devices which only employ battery power for operation and which do not operate from the AC power lines or contain provisions for operation while connected to the AC power lines.

For intentional device, Line Conducted Emission Limits are in accordance to § 15.207(a)

## **6 ANTENNA REQUIREMENT**

### **6.1 Standard Applicable**

For intentional device, according to § 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

### **6.2 Antenna Connected Construction**

The antenna of this unit is designed to be mounted permanently on the device. No consideration of replacement. Please see construction Photos Of Exhibit B for details.

## 7 HOPPING CHANNEL SEPARATION

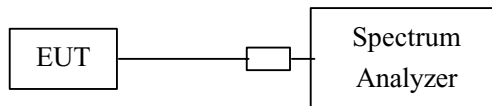
### 7.1 Standard Applicable

According to 15.247(a)(1), frequency hopping system shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater.

### 7.2 Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in figure 4 without connection to measurement instrument. Turn on the EUT and connect it to measurement instrument. The EUT must have its hopping function enabled. Then set it to any one convenient frequency within its operating range.
3. Use the following spectrum analyzer settings:  
Span = wide enough to capture the peaks of two adjacent channels  
Resolution (or IF) Bandwidth (RBW)  $\geq 1\%$  of the span  
Video (or Average) Bandwidth (VBW)  $\geq$  RBW  
Sweep = auto  
Detector function = peak  
Trace = max hold
4. Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. Plot the result on the screen of spectrum analyzer.
5. Repeat above procedures until all frequencies measured were complete.

Figure 4 : Measurement configuration.





### 7.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2004
Attenuator	Weinschel Engineering	1	N/A
Plotter	Hewlett-Packard	7440A	N/A

### 7.4 Measurement Data

Test Date : Sep. 23, 2003      Temperature : 25 °C      Humidity : 61 %

- 1) 2402 MHz : Adjacent Hopping Channel Separation is 997kHz
- 2) 2441 MHz : Adjacent Hopping Channel Separation is 997kHz
- 3) 2480 MHz : Adjacent Hopping Channel Separation is 997kHz

**Note : 1. Please see appendix 1 for Plotted Data**

**2. The expanded uncertainty of the hopping channel separation tests is 2dB.**

## 8 NUMBER OF HOPPING FREQUENCY USED

### 8.1 Standard Applicable

According to 15.247(a)(1)(iii), frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 non-overlapping channels.

### 8.2 Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in figure 4 without connection to measurement instrument. Turn on the EUT and connect it to measurement instrument. The EUT must have its hopping function enabled.
3. Use the following spectrum analyzer settings:  
Span = the frequency band of operation  
RBW  $\geq$  1% of the span  
VBW  $\geq$  RBW  
Sweep = auto  
Detector function = peak  
Trace = max hold
4. Allow the trace to stabilize. Plot the result on the screen of spectrum analyzer.
5. Repeat above procedures until all frequencies measured were complete.

### 8.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2004
Attenuator	Weinschel Engineering	1	N/A
Plotter	Hewlett-Packard	7440A	N/A

## 8.4 Measurement Data

Test Date : Sep. 23, 2003      Temperature : 25 °C      Humidity : 61 %

There are 79 hopping frequencies in a hopping sequence.

***Note : 1. Please see appendix 2 for Plotted Data***

***2. The expanded uncertainty of number of hopping frequency used tests is 2dB.***

## 9 CHANNEL BANDWIDTH

### 9.1 Standard Applicable

According to 15.247(a)(1)(ii), for frequency hopping system operating in the 5725-5850 MHz band, the maximum 20dB bandwidth of the hopping channel is 1MHz.

### 9.2 Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in figure 4 without connection to measurement instrument. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range.
3. Use the following spectrum analyzer settings:  
Span = approximately 2 to 3 times the 20 dB bandwidth, centered on a hopping channel  
RBW  $\geq$  1% of the 20 dB bandwidth  
VBW  $\geq$  RBW  
Sweep = auto  
Detector function = peak  
Trace = max hold
4. Allow the trace to stabilize. Use the marker-to-peak function to set the marker to the peak of the emission. Use the marker-delta function to measure 20 dB down one side of the emission. Reset the marker-delta function, and move the marker to the other side of the emission, until it is (as close as possible to) even with the reference marker level. The marker-delta reading at this point is the 20 dB bandwidth of the emission. Plot the result on the screen of spectrum analyzer.
5. Repeat above procedures until all frequencies measured were complete.

### 9.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2004
Attenuator	Weinschel Engineering	1	N/A
Plotter	Hewlett-Packard	7440A	N/A

## 9.4 Measurement Data

Test Date : Sep. 23, 2003      Temperature : 25 °C      Humidity : 61 %

- 1) 2402 MHz : Channel Bandwidth is 817 kHz
- 2) 2441 MHz : Channel Bandwidth is 817 kHz
- 3) 2480 MHz : Channel Bandwidth is 817 kHz

***Note : 1. Please see appendix 3 for Plotted Data***

***2. The expanded uncertainty of channel bandwidth tests is 2dB.***

## 10 DWELL TIME ON EACH CHANNEL

### 10.1 Standard Applicable

According to 15.247(a)(1)(iii), for frequency hopping system operating in the 2400-2483.5 band, the average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

### 10.2 Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in figure 4 without connection to measurement instrument. Turn on the EUT and connect it to measurement instrument. The EUT must have its hopping function enabled.
3. Use the following spectrum analyzer settings:  
Span = zero span, centered on a hopping channel  
RBW = 1 MHz  
VBW  $\geq$  RBW  
Sweep = as necessary to capture the entire dwell time per hopping channel  
Detector function = peak  
Trace = max hold
4. Use the marker-delta function to determine the dwell time. Plot the result on the screen of spectrum analyzer.
5. Repeat above procedures until all frequencies measured were complete.

### 10.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2004
Attenuator	Weinschel Engineering	1	N/A
Plotter	Hewlett-Packard	7440A	N/A

## 10.4 Measurement Data

Test Date : Sep. 23, 2003      Temperature : 25 °C      Humidity : 61 %

- 1) 2402 MHz : the dwell time is  $102 \times 3.16 \times 500 \mu\text{s} = 161.16 \text{ ms}$
- 2) 2441 MHz : the dwell time is  $102 \times 3.16 \times 500 \mu\text{s} = 161.16 \text{ ms}$
- 3) 2480 MHz : the dwell time is  $102 \times 3.16 \times 500 \mu\text{s} = 161.16 \text{ ms}$

The maximum time of occupancy for a particular channel is 161.16 msec in any period, which is less than the 400 msec allowed by the rules; therefore, it meets the requirements of this section.

**Note : 1. Please see appendix 4 for Plotted Data**

**2. The expanded uncertainty of dwell time on each channel tests is 2dB.**

## 11 OUTPUT POWER MEASUREMENT

### 11.1 Standard Applicable

According to 15.247(b)(1), for frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt.

For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.

### 11.2 Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in figure 4 without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
3. Use the following spectrum analyzer settings:  
Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel  
RBW > the 20 dB bandwidth of the emission being measured  
VBW  $\geq$  RBW  
Sweep = auto  
Detector function = peak  
Trace = max hold
4. Allow the trace to stabilize. Use the marker-to-peak function to set the marker to the peak of the emission. The indicated level is the peak output power. Plot the result on the screen of spectrum analyzer.
5. Repeat above procedures until all frequencies measured were complete.

### 11.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2004
Attenuator	Weinschel Engineering	1	N/A
Plotter	Hewlett-Packard	7440A	N/A



## 11.4 Measurement Data

Test Date : Sep. 23, 2003      Temperature : 23 °C      Humidity : 61 %

- 1) 2402 MHz : Output Peak Power is -5.33 dBm = 0.29mW
- 2) 2441 MHz : Output Peak Power is -3.33 dBm = 0.46mW
- 3) 2480 MHz : Output Peak Power is -4.67 dBm = 0.34mW

**Note : 1. Please see appendix 5 for Plotted Data**

**2. The expanded uncertainty of output power measurement tests is 2dB.**

## 12 100 kHz BANDWIDTH OF BAND EDGES MEASUREMENT

### 12.1 Standard Applicable

According to 15.247(c), in any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required.

### 12.2 Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in figure 4 without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
3. Use the following spectrum analyzer settings:  
 Span = wide enough to capture the peak level of the emission operating on the channel closest to the bandedge, as well as any modulation products which fall outside of the authorized band of operation  
 $RBW \geq 1\%$  of the span  
 $VBW \geq RBW$   
 Sweep = auto  
 Detector function = peak  
 Trace = max hold
4. Allow the trace to stabilize. Set the marker on the emission at the bandedge, or on the highest modulation product outside of the band, if this level is greater than that at the bandedge. Enable the marker-delta function, then use the marker-to-peak function to move the marker to the peak of the in-band emission. Plot the result on the screen of spectrum analyzer.
5. Repeat above procedures until all measured frequencies were complete.

### 12.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2004
Attenuator	Weinschel Engineering	1	N/A
Plotter	Hewlett-Packard	7440A	N/A

## 12.4 Measurement Data

Test Date : Sep. 23, 2003      Temperature : 25 °C      Humidity : 61 %

- a) Lower Band Edge : All emissions in this 100kHz bandwidth are attenuated more than 20dB from the carrier.
- b) Upper Band Edge : All emissions in this 100kHz bandwidth are attenuated more than 20dB from the carrier.

***Note : 1. Please see appendix 6 for Plotted Data***

***2. The expanded uncertainty of the 100 KHz bandwidth of band edges tests is 1000Hz.***

## 13 OUT-OF-BAND CONDUCTED EMISSION MEASUREMENT

### 13.1 Standard Applicable

According to 15.247(c), in any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required.

### 13.2 Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in figure 4 without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
3. Use the following spectrum analyzer settings:  
 Span = wide enough to capture the peak level of the in-band emission and all spurious emissions (e.g., harmonics) from the lowest frequency generated in the EUT up through the 10th harmonic. Typically, several plots are required to cover this entire span.  
 RBW = 100 kHz  
 VBW  $\geq$  RBW  
 Sweep = auto  
 Detector function = peak  
 Trace = max hold.
4. Allow the trace to stabilize. Set the marker on the peak of any spurious emission recorded. Plot the result on the screen of spectrum analyzer.
5. Repeat above procedures until all measured frequencies were complete.

### 13.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2004
Attenuator	Weinschel Engineering	1	N/A
Plotter	Hewlett-Packard	7440A	N/A

## 13.4 Measurement Data

### Mode : Low Channel

Test Date : Sep. 23, 2003      Temperature : 25 °C      Humidity : 61 %

- a) 1 GHz to 5 GHz frequency band: All emissions are attenuated more than 20dB from the carrier.
- b) 5 GHz to 25 GHz frequency band: All emissions are attenuated more than 20dB from the carrier.

### Mode : Mid Channel

Test Date : Sep. 23, 2003      Temperature : 25 °C      Humidity : 61 %

- a) 1 GHz to 5 GHz frequency band: All emissions are attenuated more than 20dB from the carrier.
- b) 5 GHz to 25 GHz frequency band: All emissions are attenuated more than 20dB from the carrier.

### Mode : Hi Channel

Test Date : Sep. 23, 2003      Temperature : 25 °C      Humidity : 61 %

- c) 1 GHz to 5 GHz frequency band: All emissions are attenuated more than 20dB from the carrier.
- d) 5 GHz to 25 GHz frequency band: All emissions are attenuated more than 20dB from the carrier.

**Note : 1. Please see appendix 7 for Plotted Data**

**2. The expanded uncertainty of the out-of-band conducted emission tests is 2dB.**

## 14 PEAK POWER SPECTRAL DENSITY MEASUREMENT

### 14.1 Standard Applicable

According to 15.247(d), for digitally modulated systems, the peak power spectral density conducted from the intentional radiator to the antenna shall not be greater than 8 dBm in any 3 kHz band during any time interval of continuous transmission.

### 14.2 Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in figure 4 without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set EUT to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
3. Use the following spectrum analyzer settings:  
Span = 300 kHz, centered on highest level appearing on spectral display  
RBW = 3 kHz  
VBW  $\geq$  RBW  
Sweep = 100 s  
Detector function = peak  
Trace = max hold
4. Allow the trace to stabilize. Use the marker-to-peak function to set the marker to the peak of the emission. Plot the result on the screen of spectrum analyzer.
5. Repeat above procedures until all measured frequencies were complete.

### 14.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2004
Attenuator	Weinschel Engineering	1	N/A
Plotter	Hewlett-Packard	7440A	N/A

## 14.4 Measurement Data

Test Date : Sep. 25, 2003      Temperature : 25 °C      Humidity: 60 %

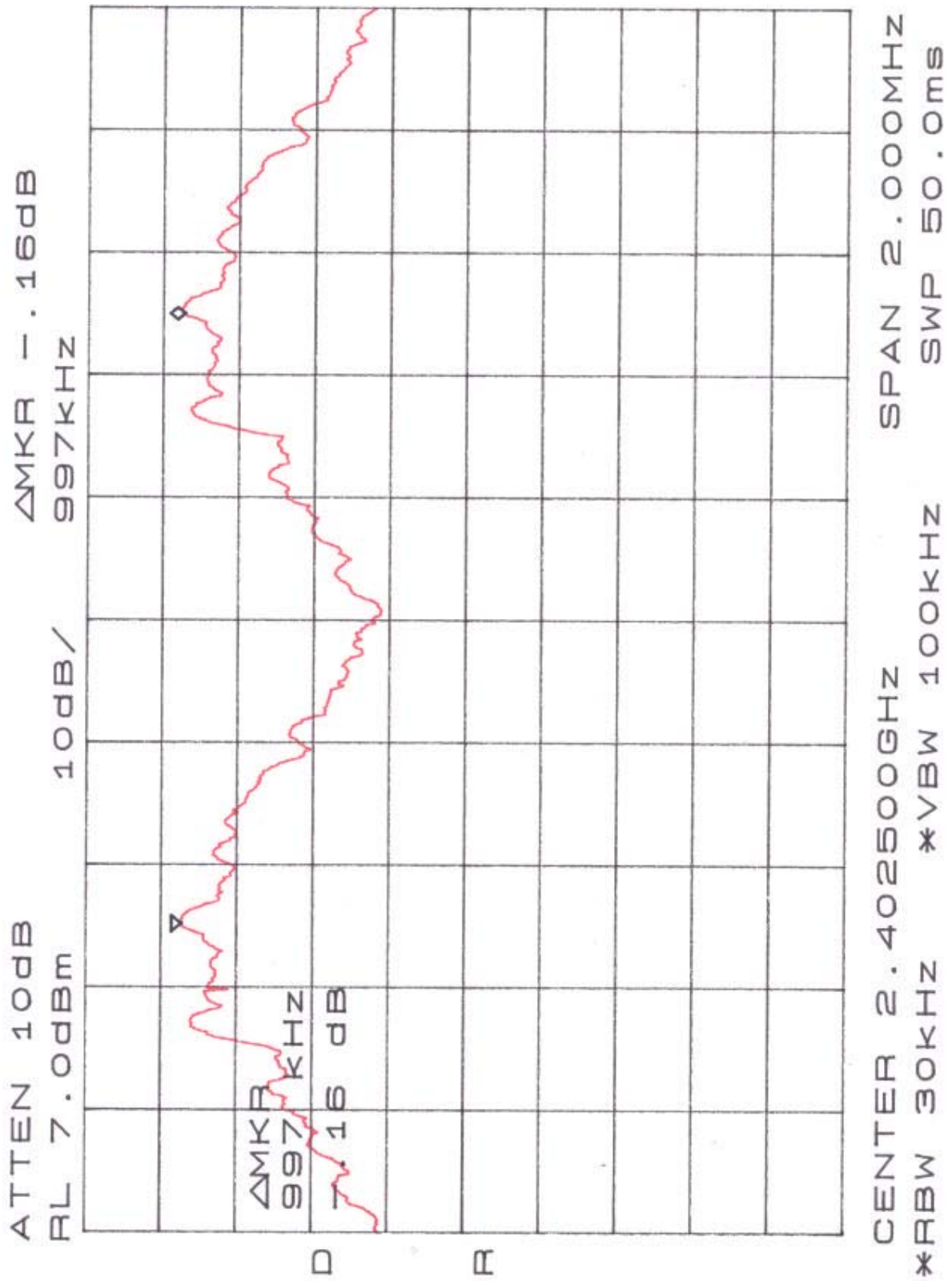
- a) 2402MHz : Maximun Power Density of 3 kHz Bandwidth is -15.67dBm
- b) 2441MHz : Maximun Power Density of 3 kHz Bandwidth is -13.67dBm
- c) 2480MHz : Maximun Power Density of 3 kHz Bandwidth is -14.83dBm

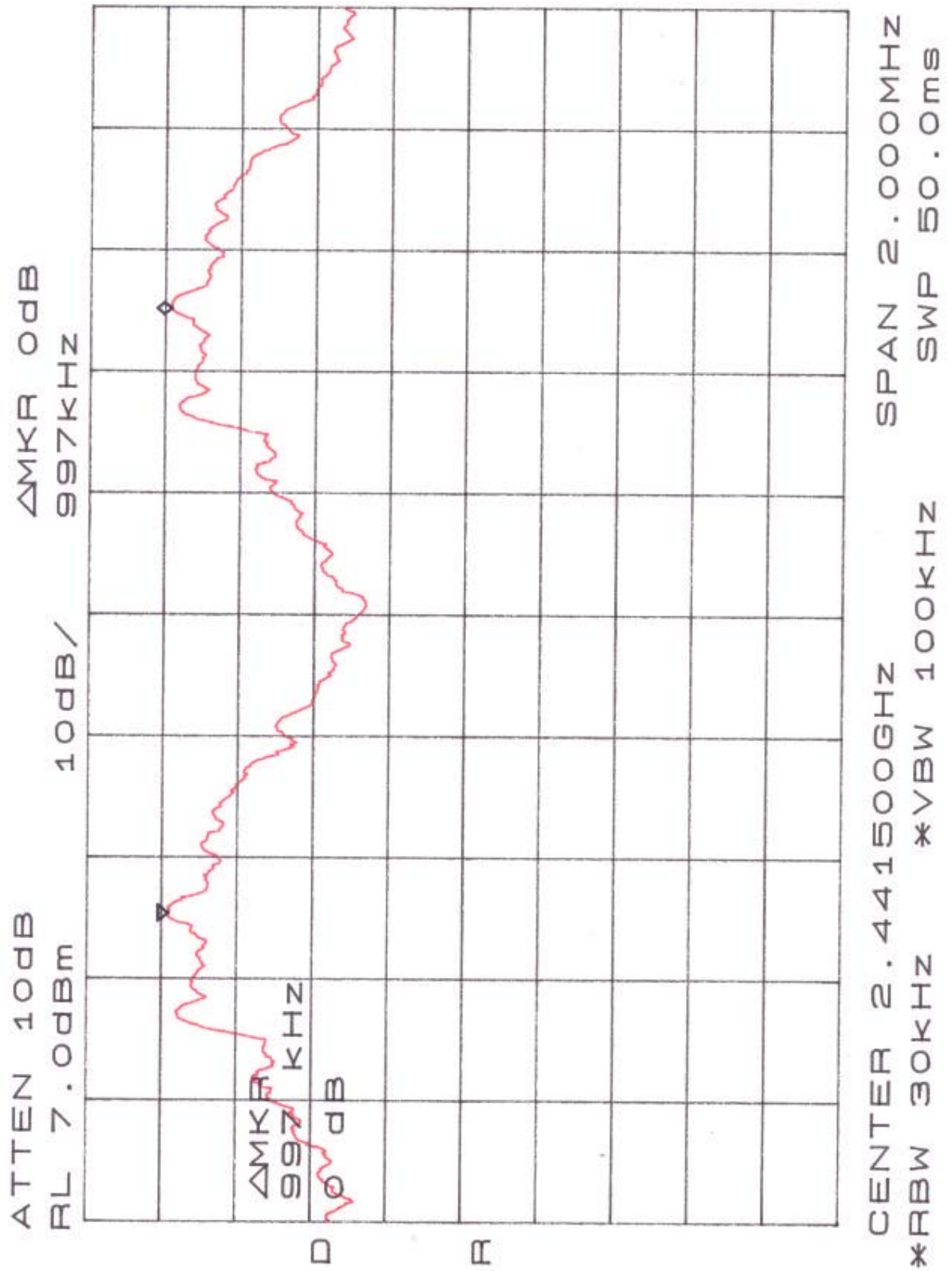
***Note : 1. Please see appendix 8 for Plotted Data***

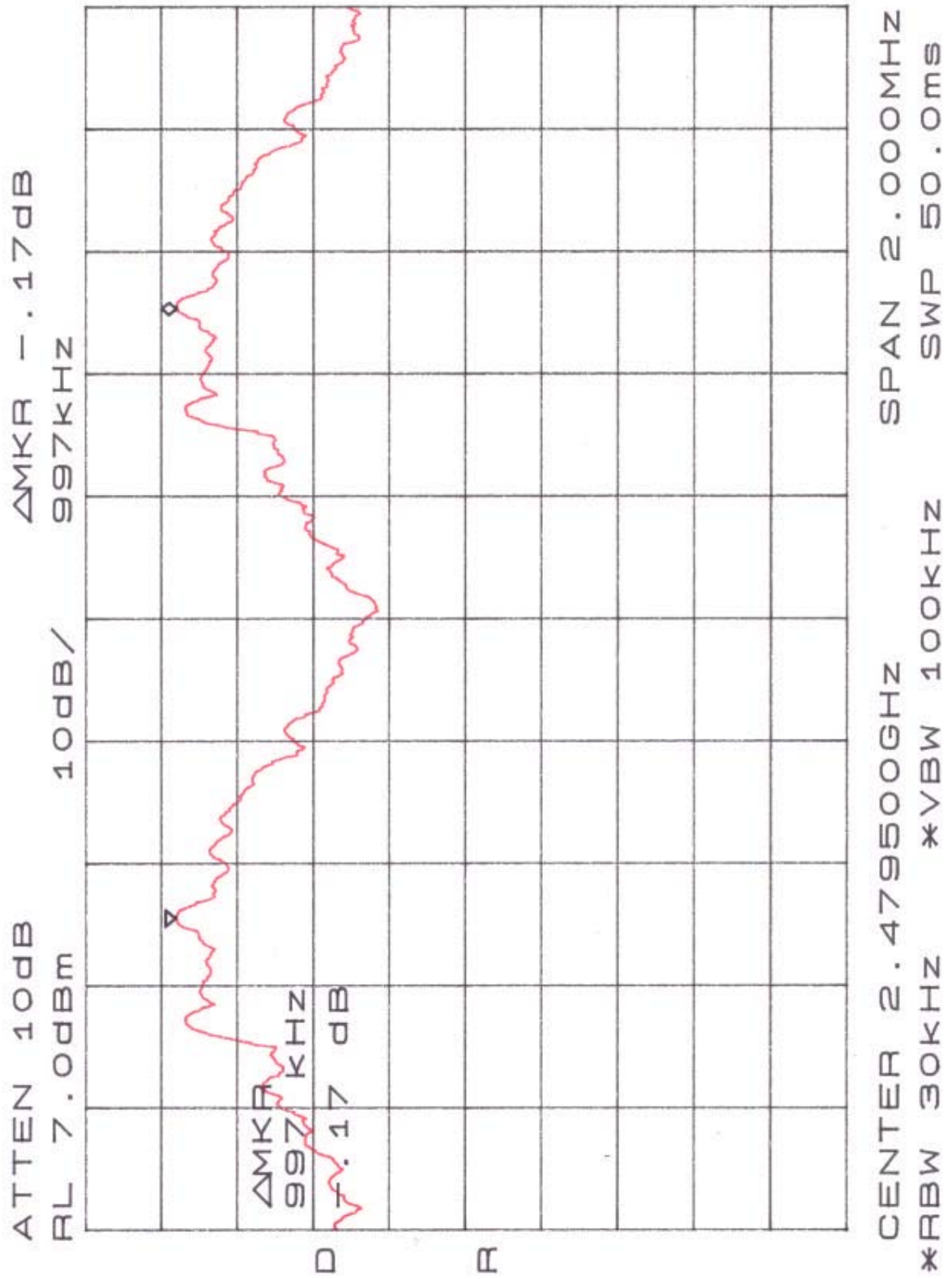
***2. The expanded uncertainty of the power density tests is 2dB.***

## **Appendix 1 : Plotted Data for Separation of Adjacent Channel**

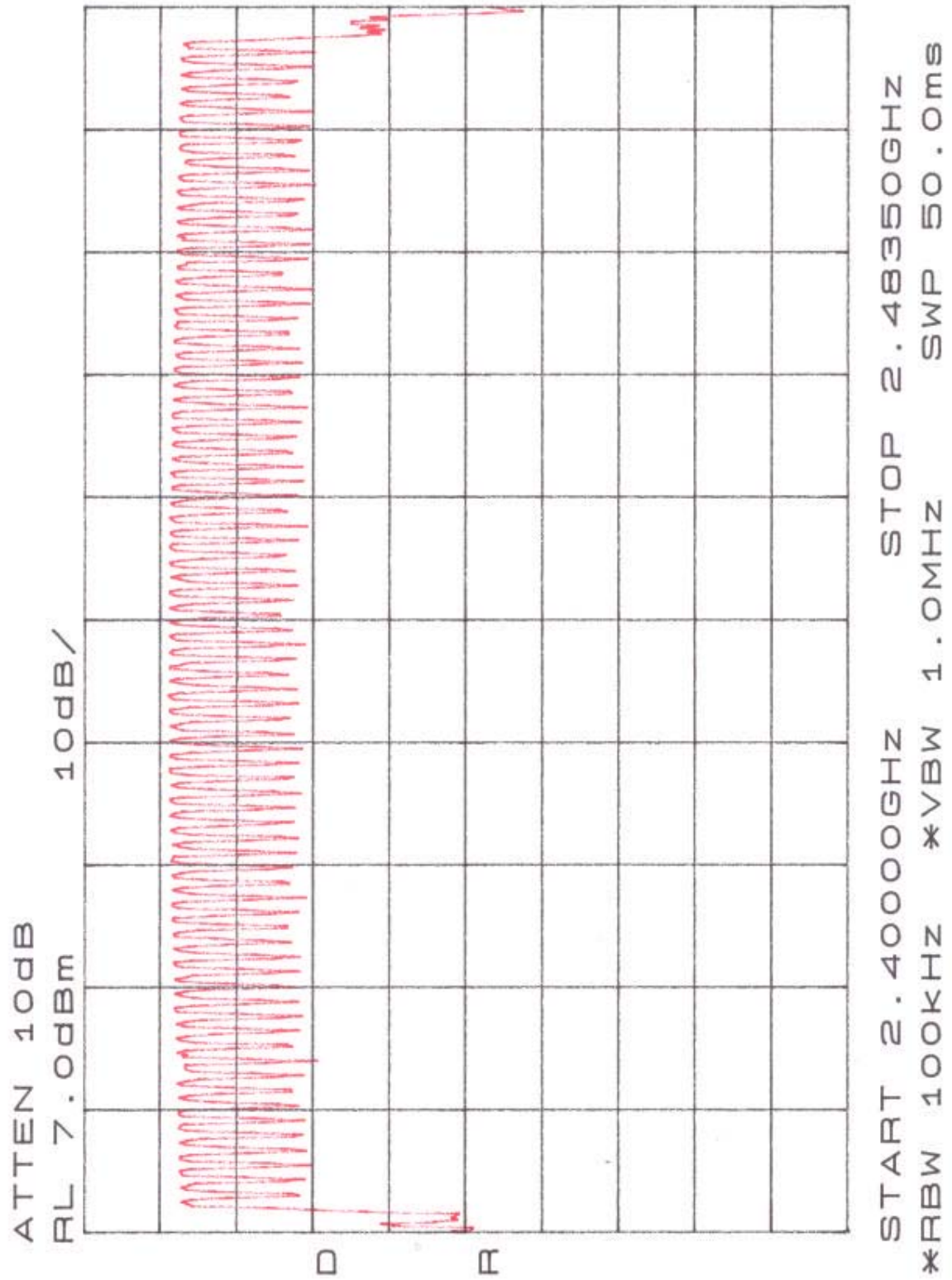




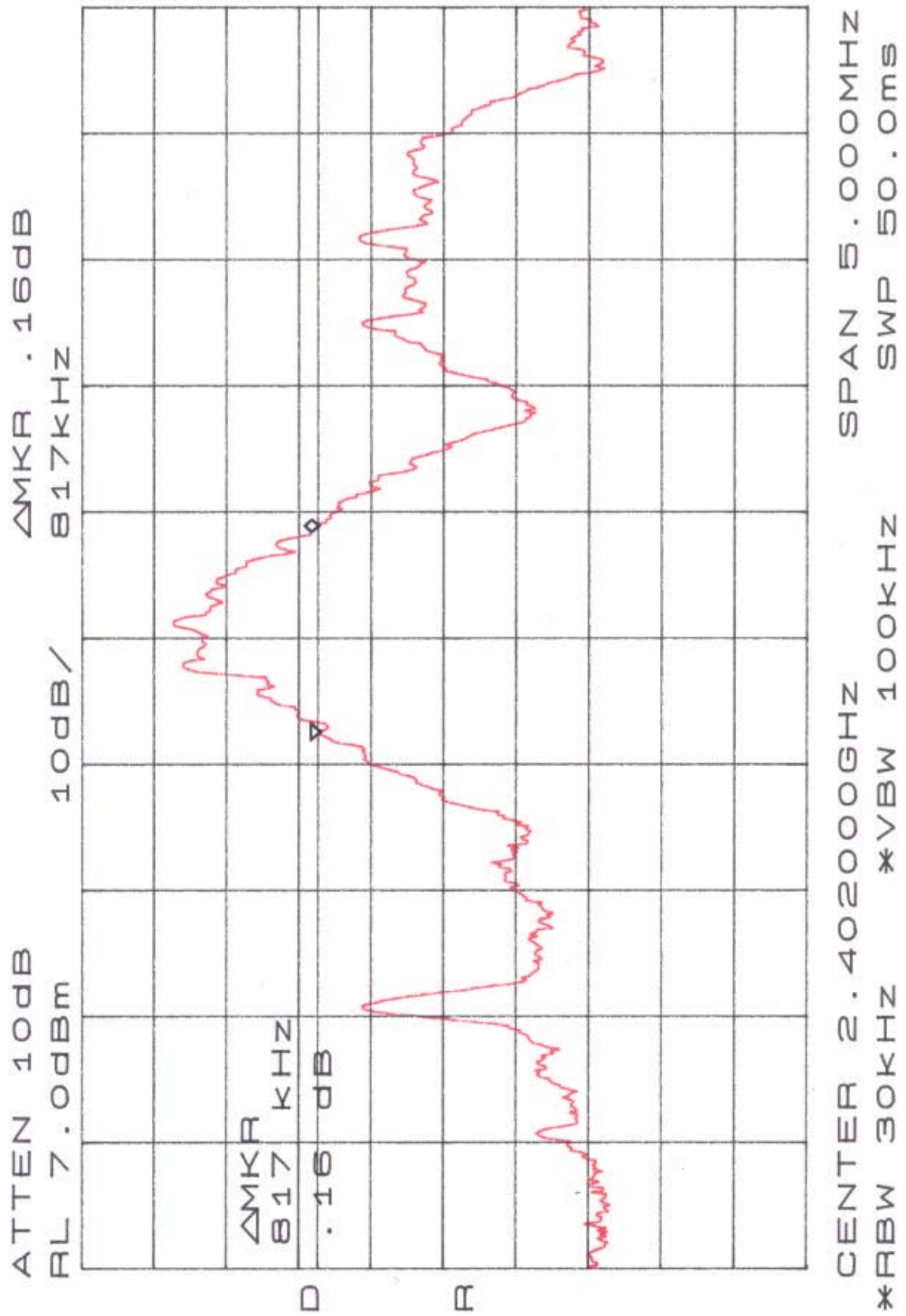




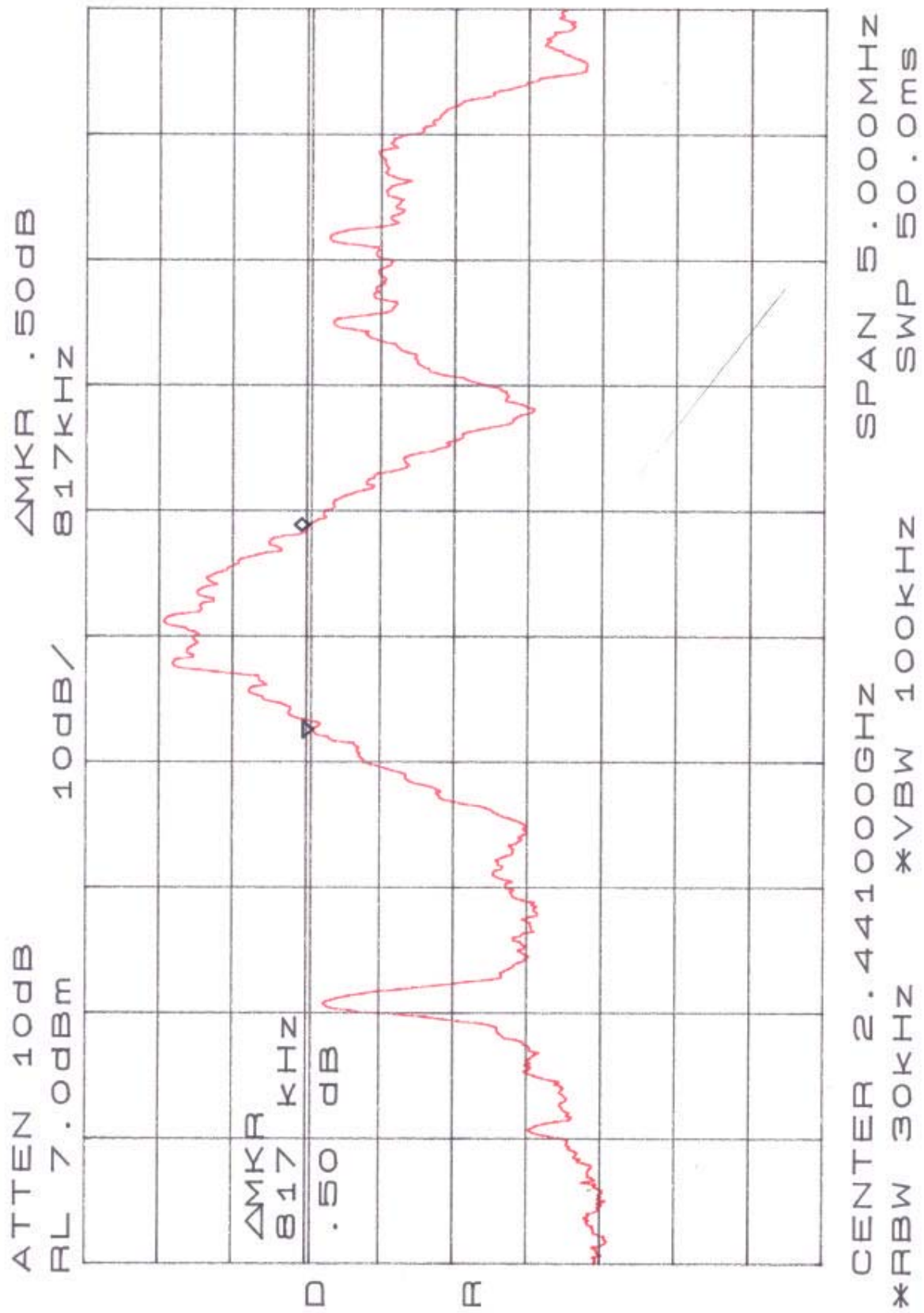
## **Appendix 2 : Plotted Data for Total Used Hopping Frequencies**



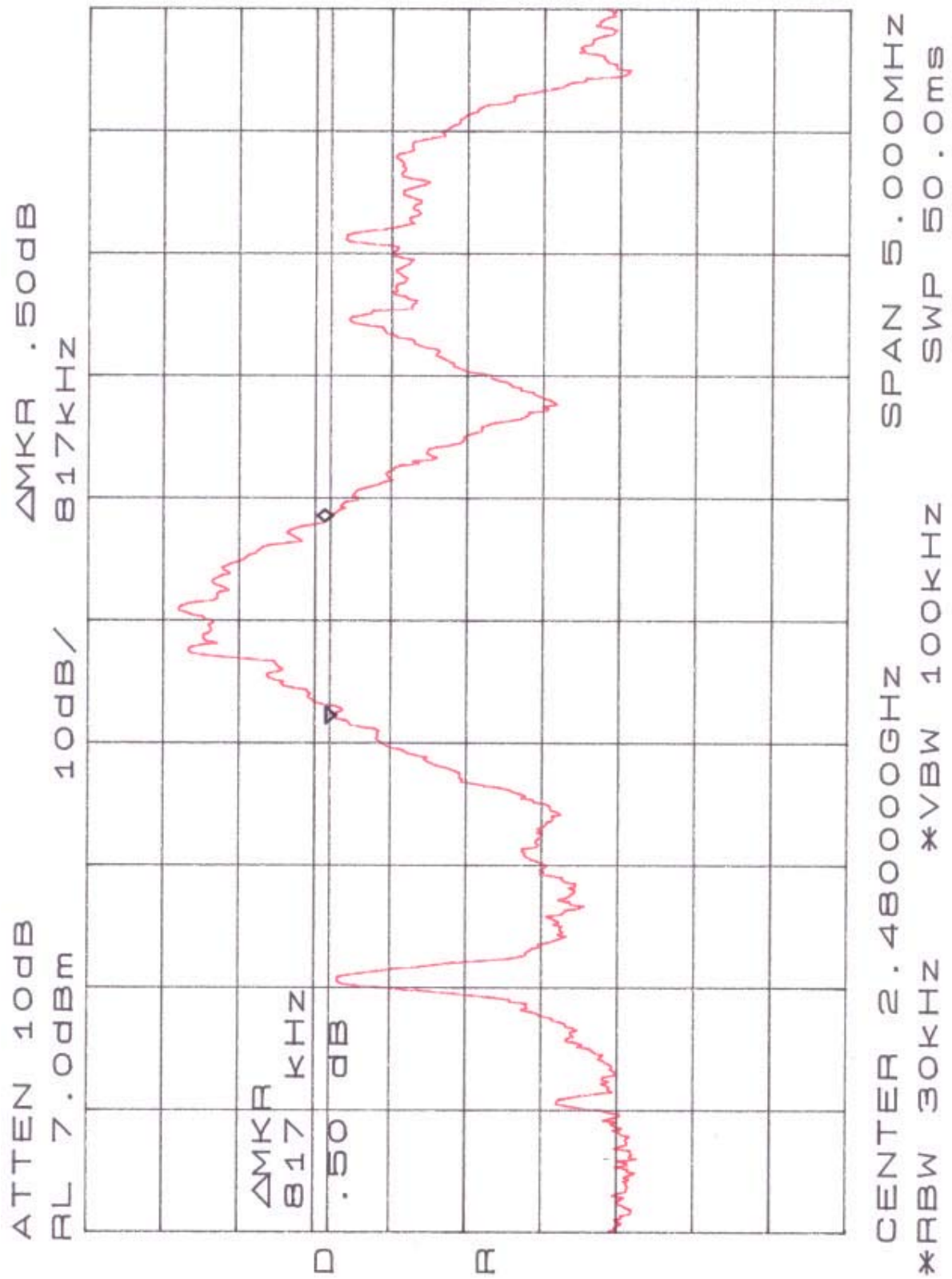
### **Appendix 3 : Plotted Data for Channel Bandwidth**



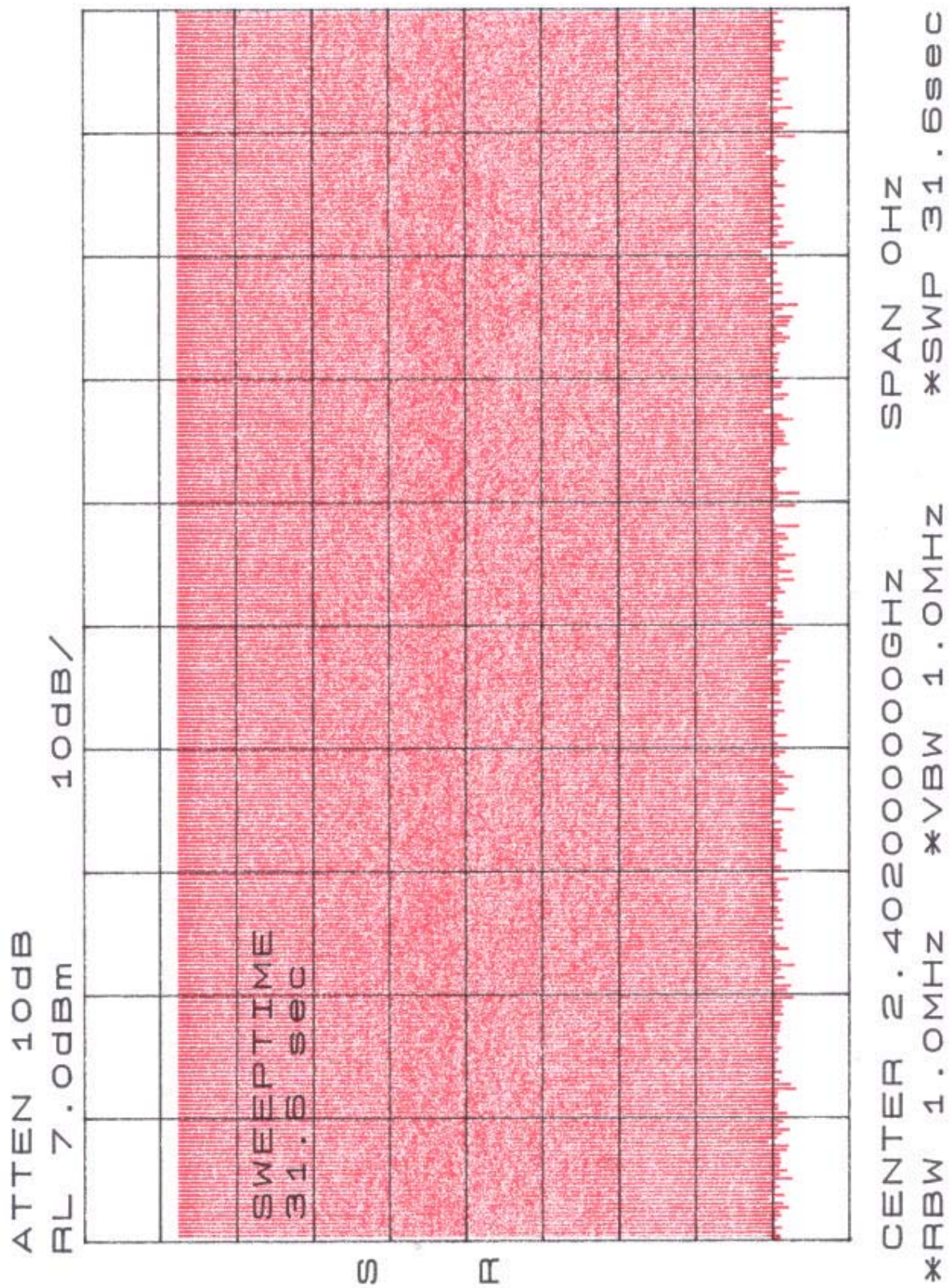




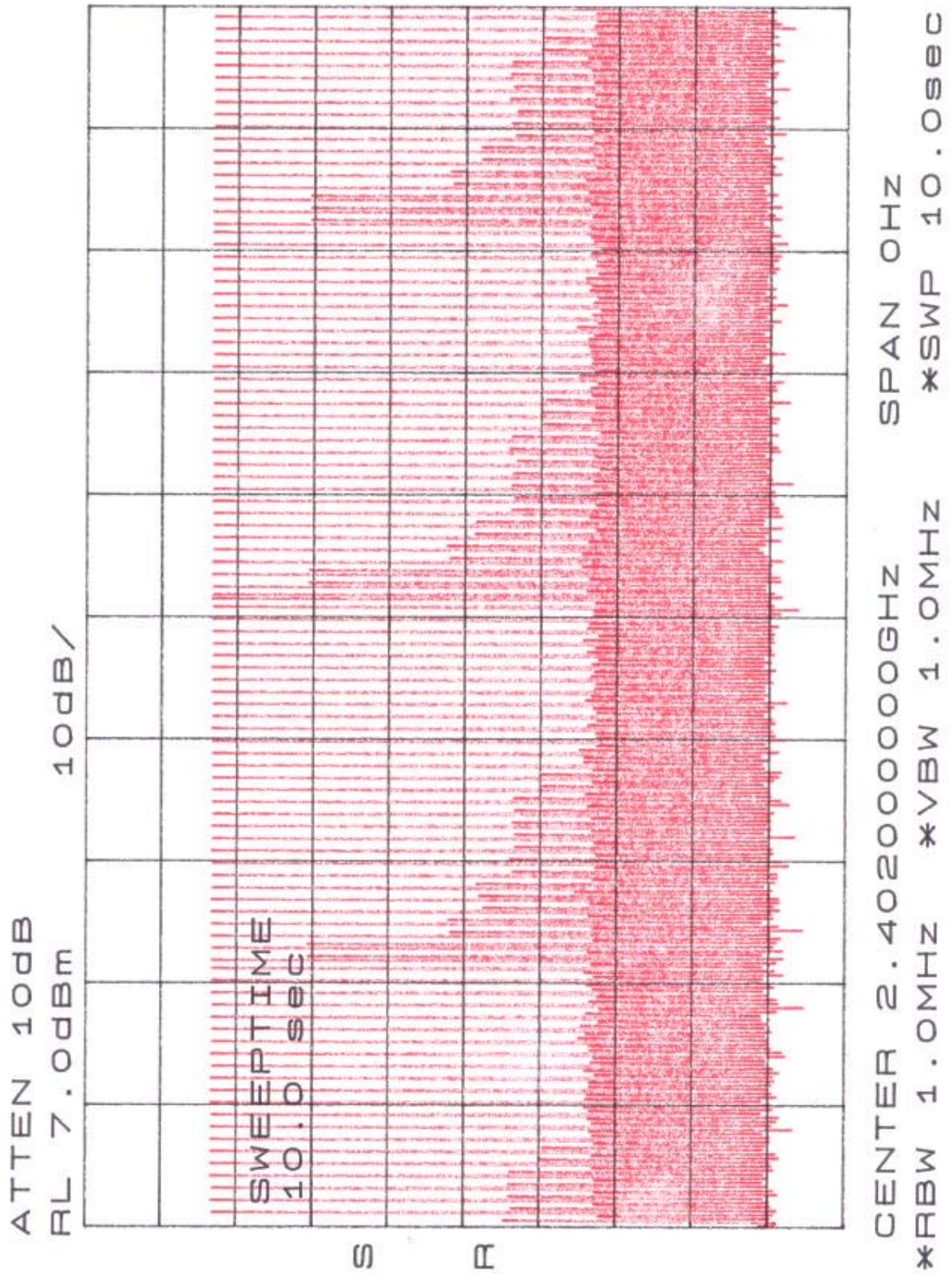


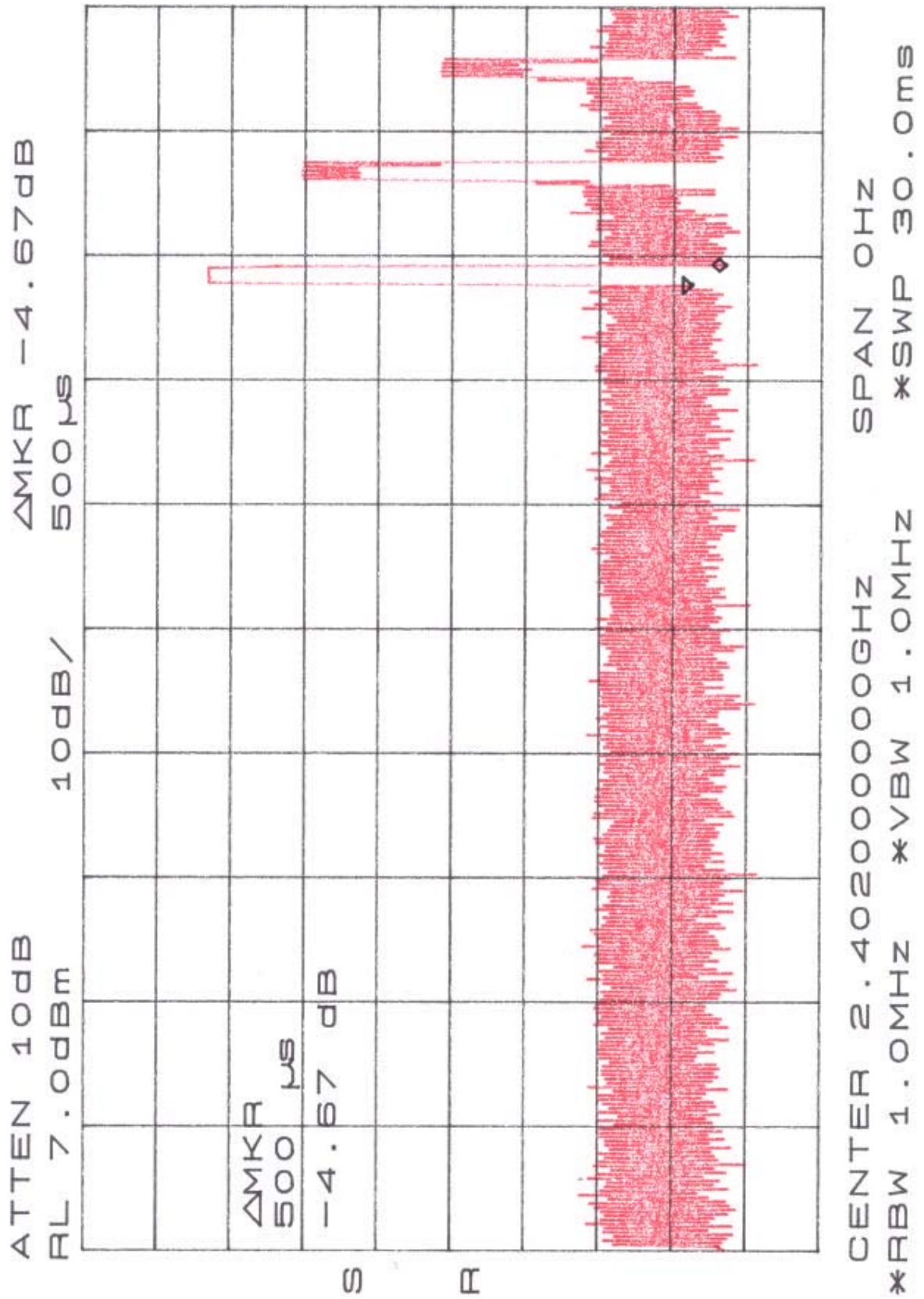


## **Appendix 4 : Plotted Data for Channel Dwell Time**

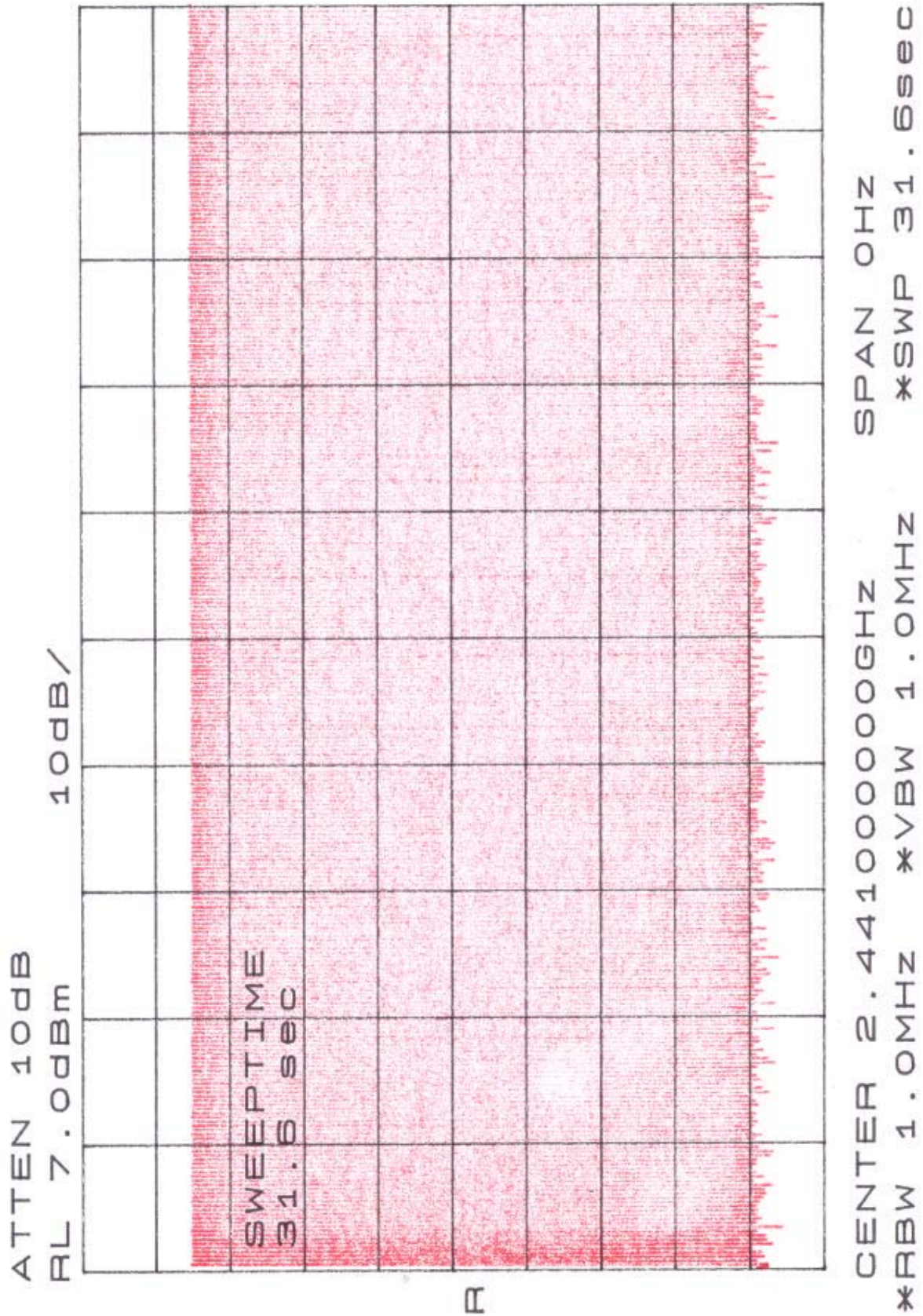


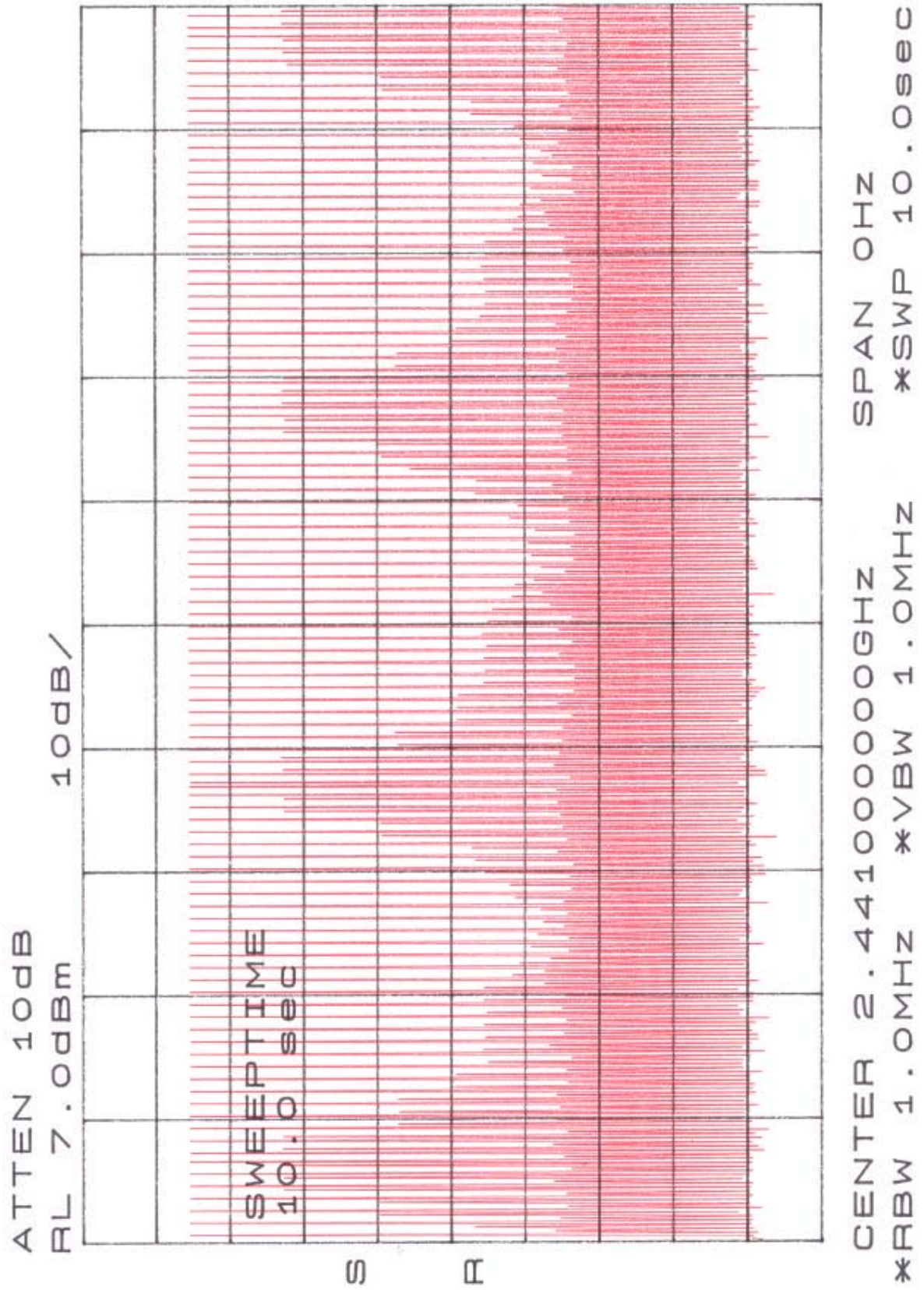




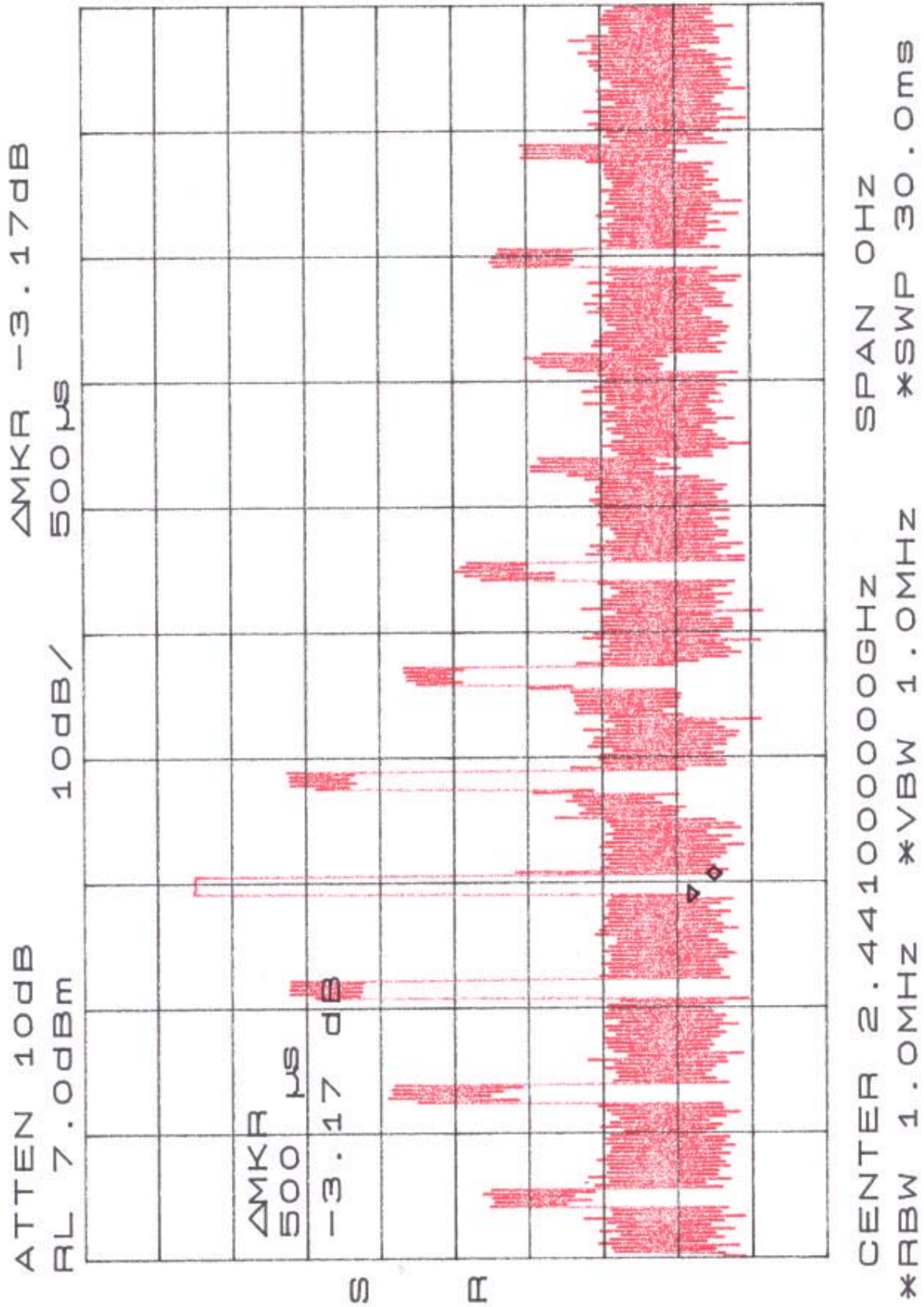




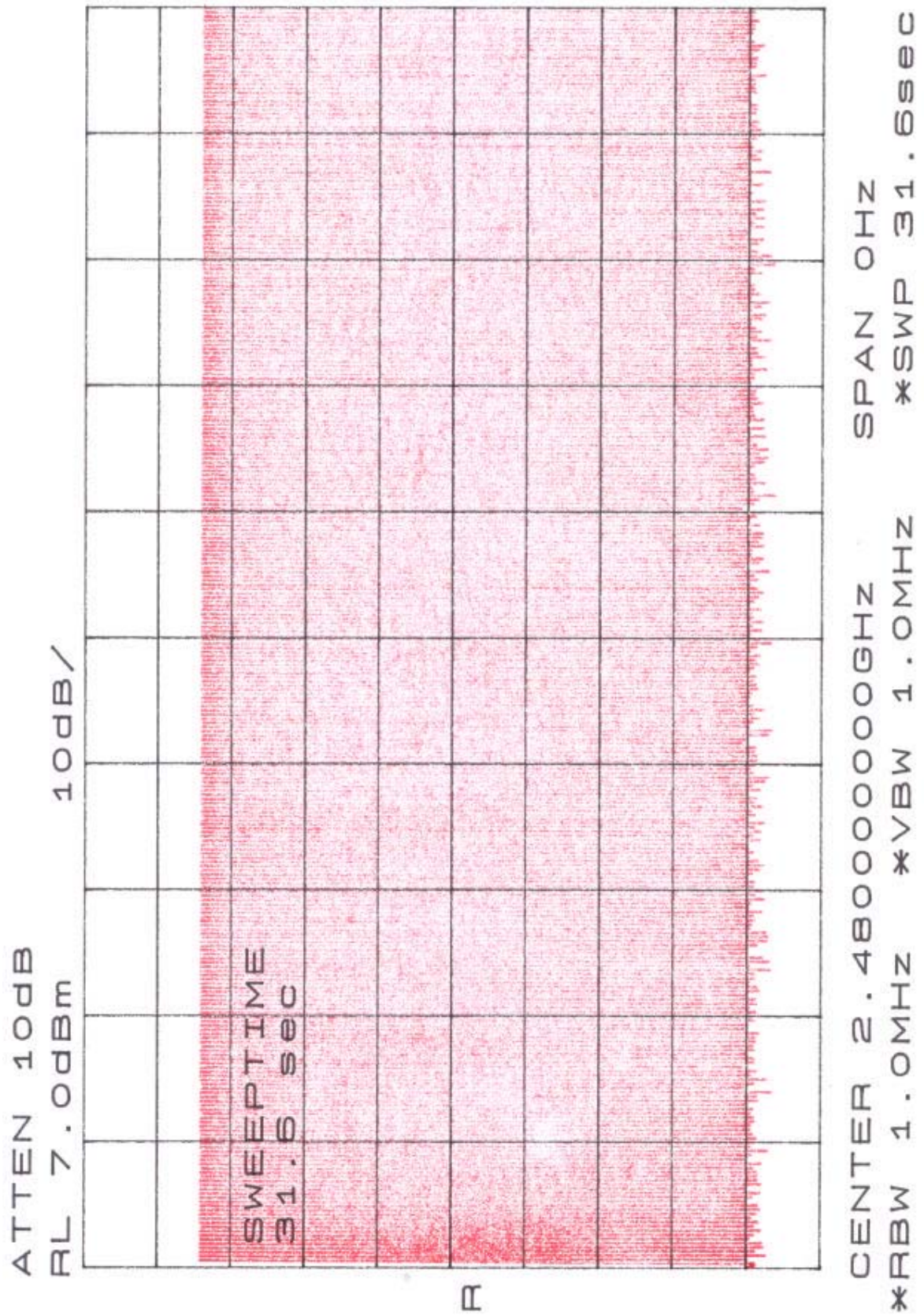




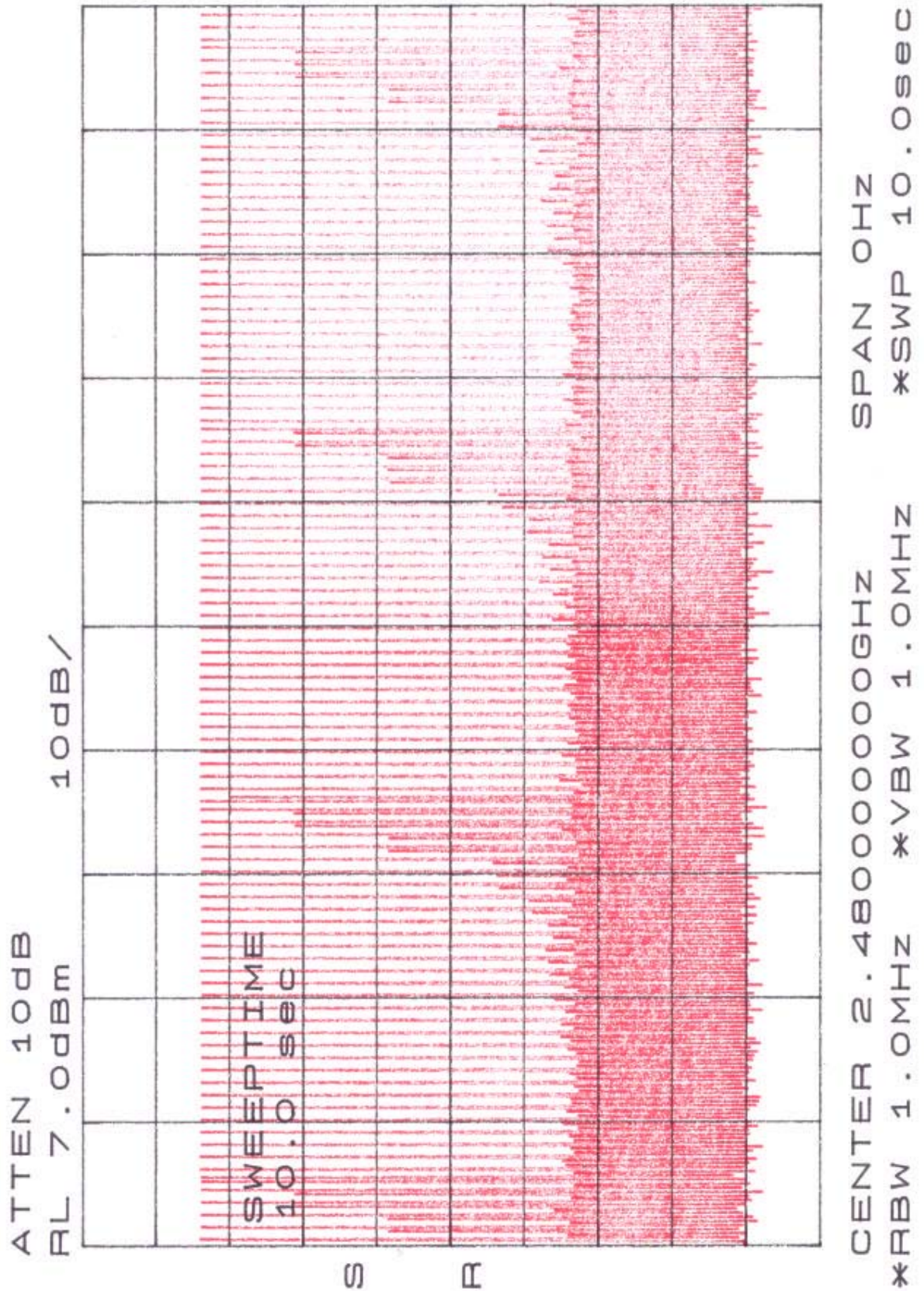


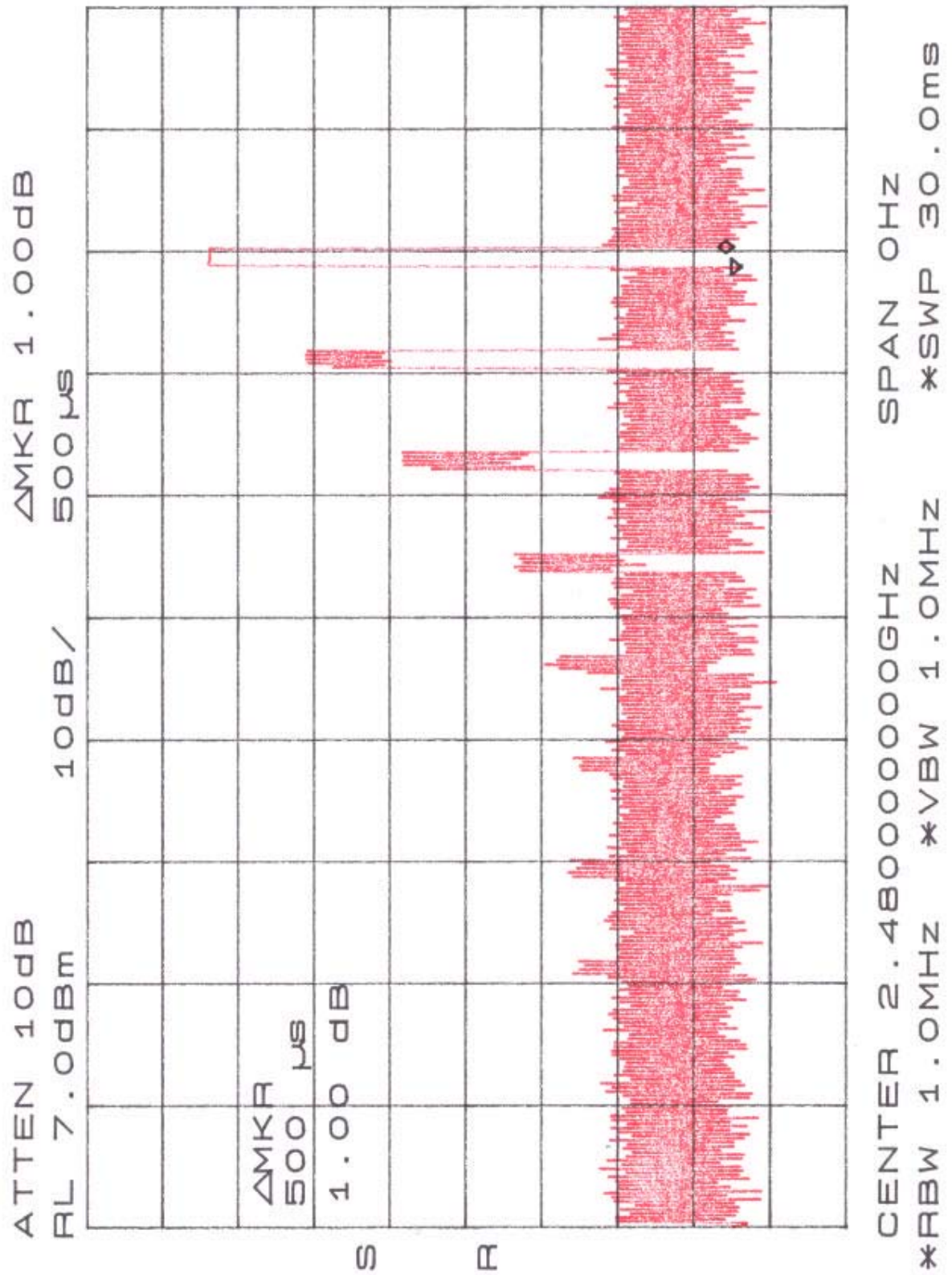






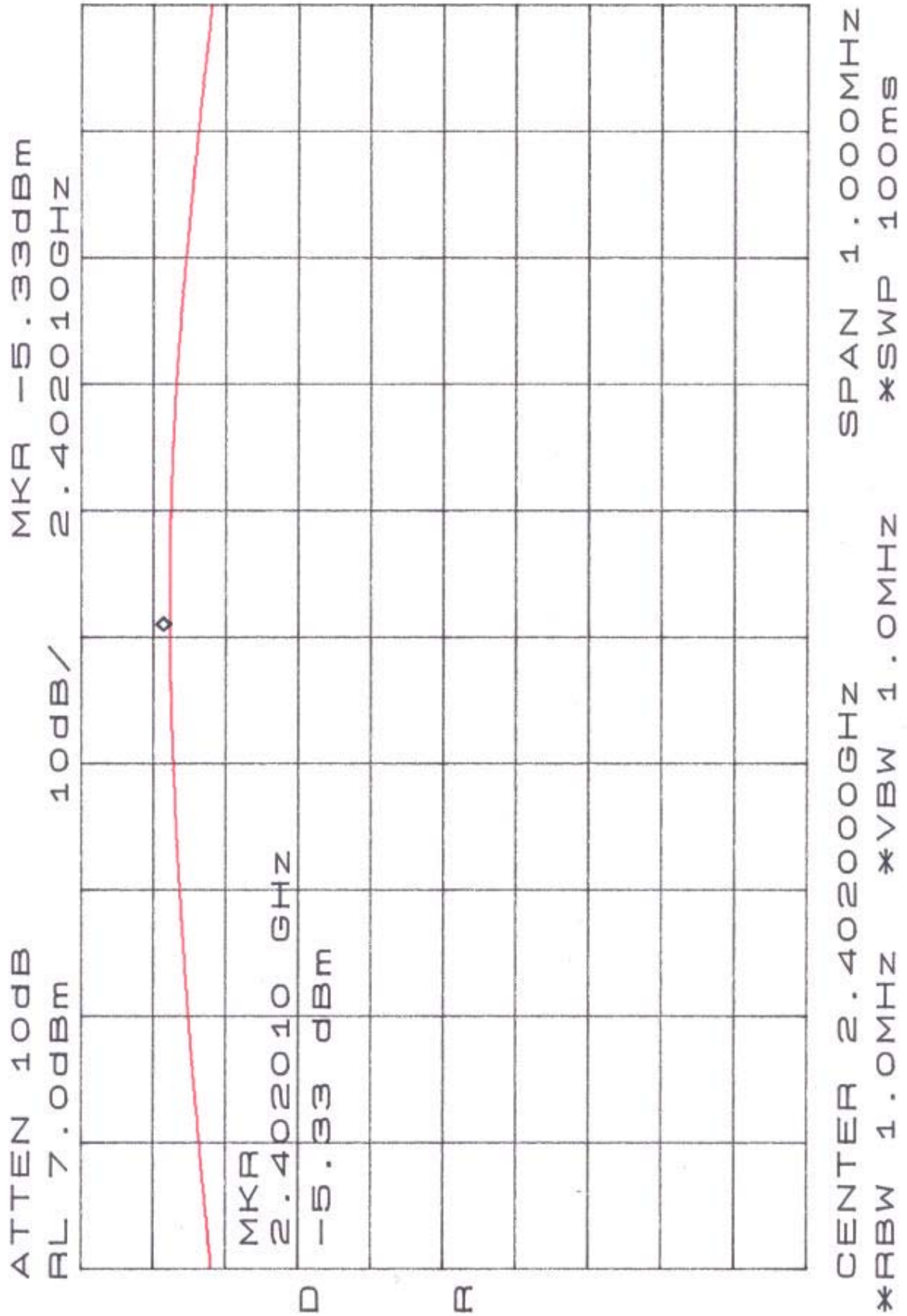


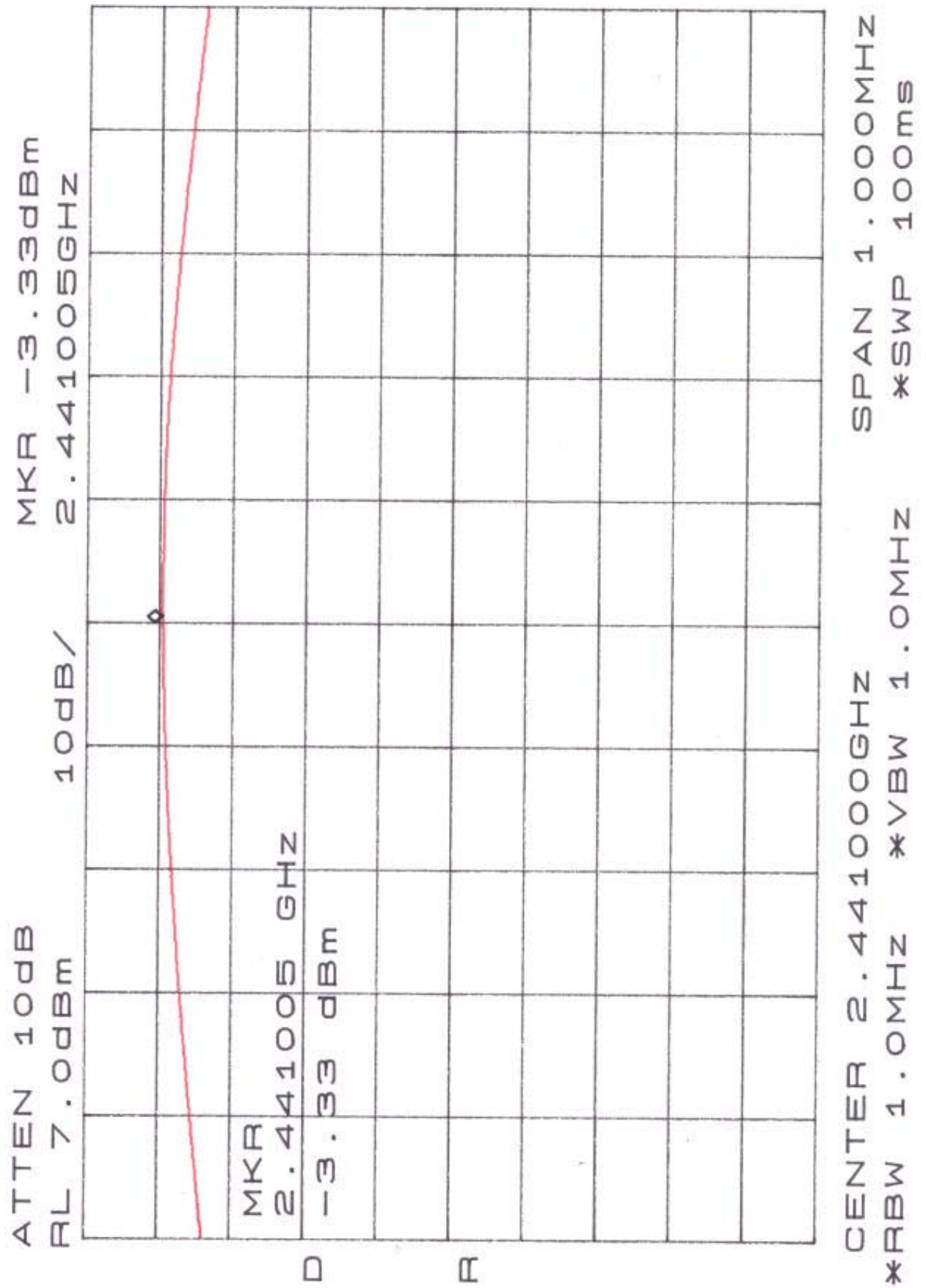


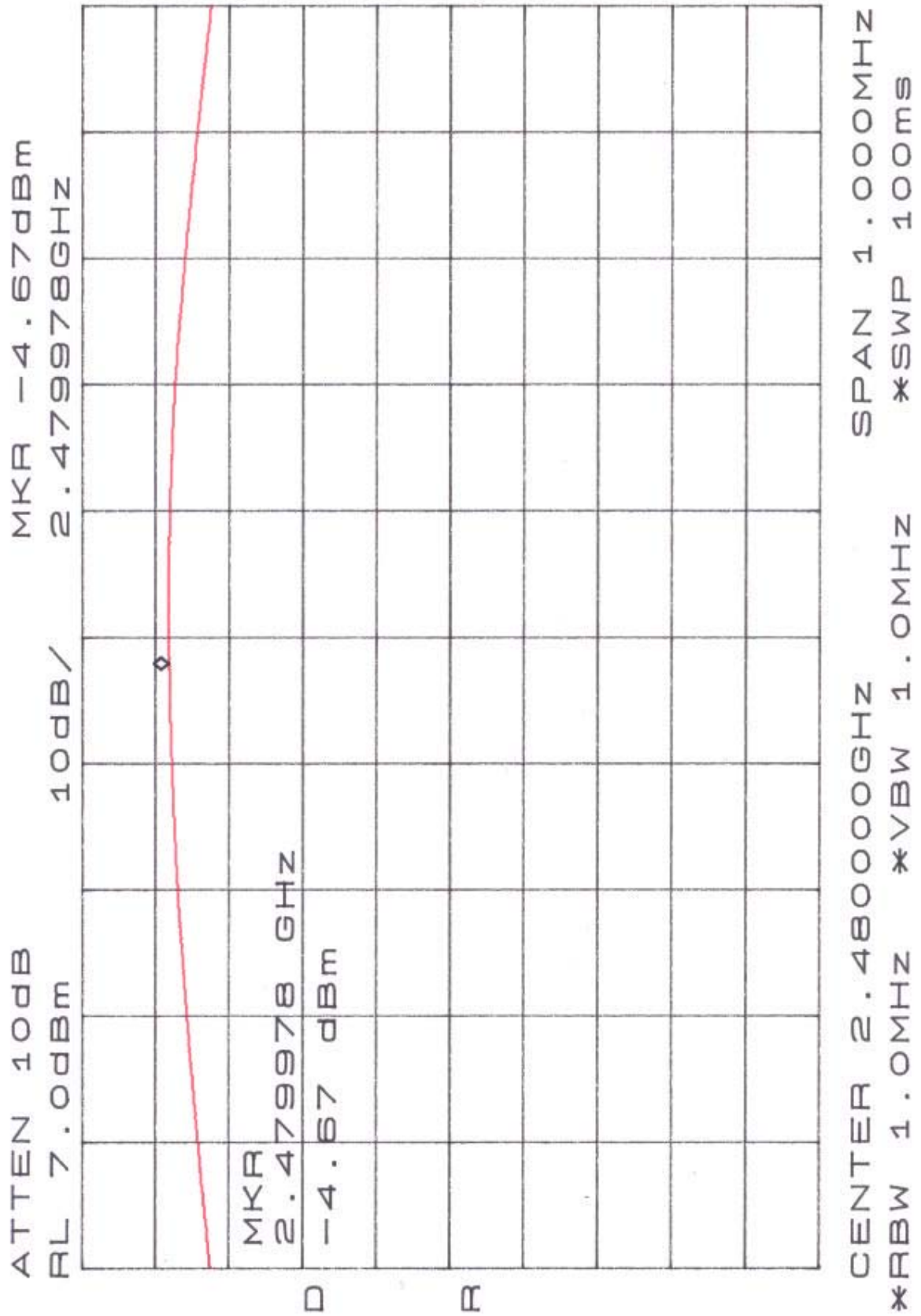


## **Appendix 5 : Plotted Data for Output Peak Power**



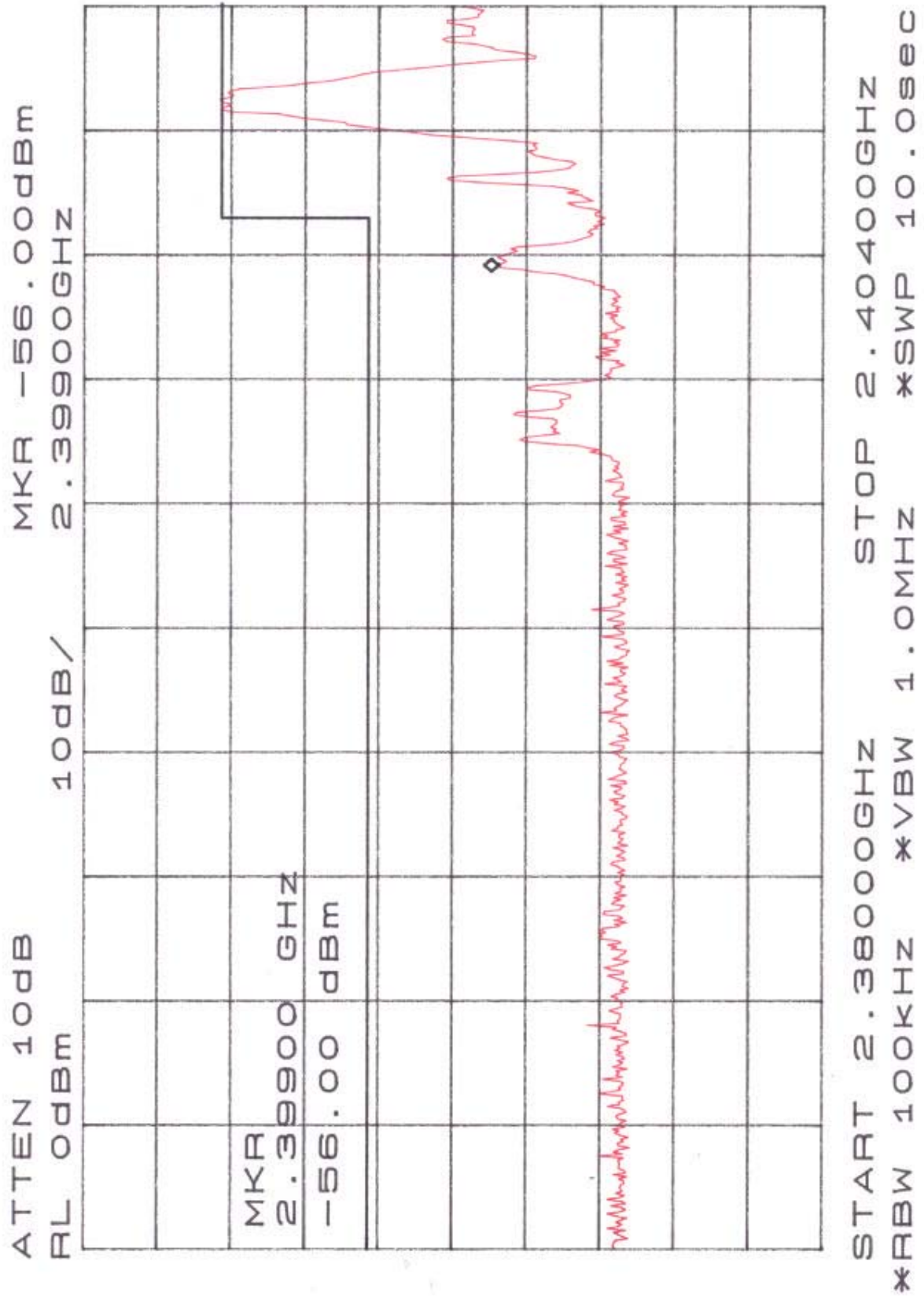


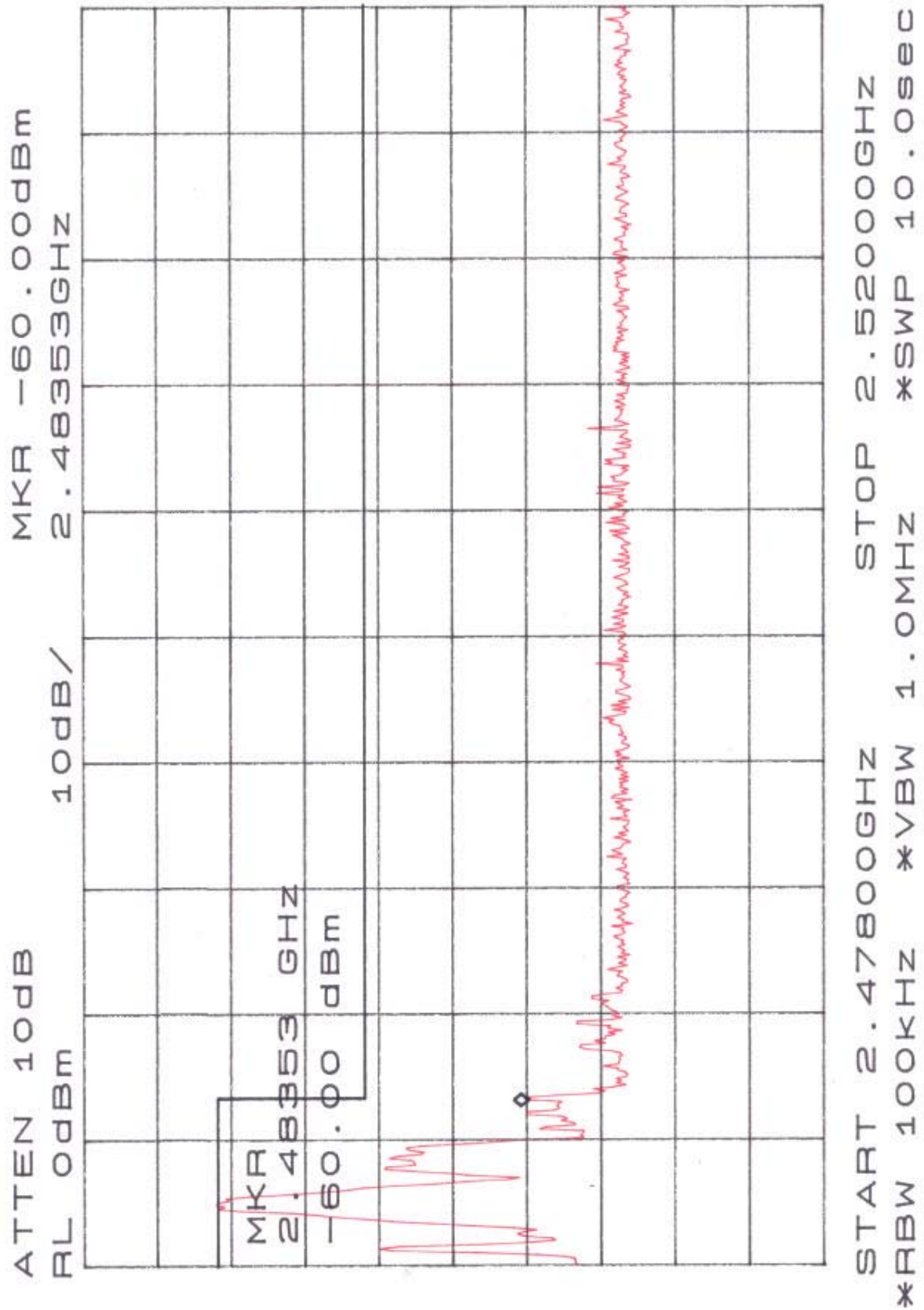




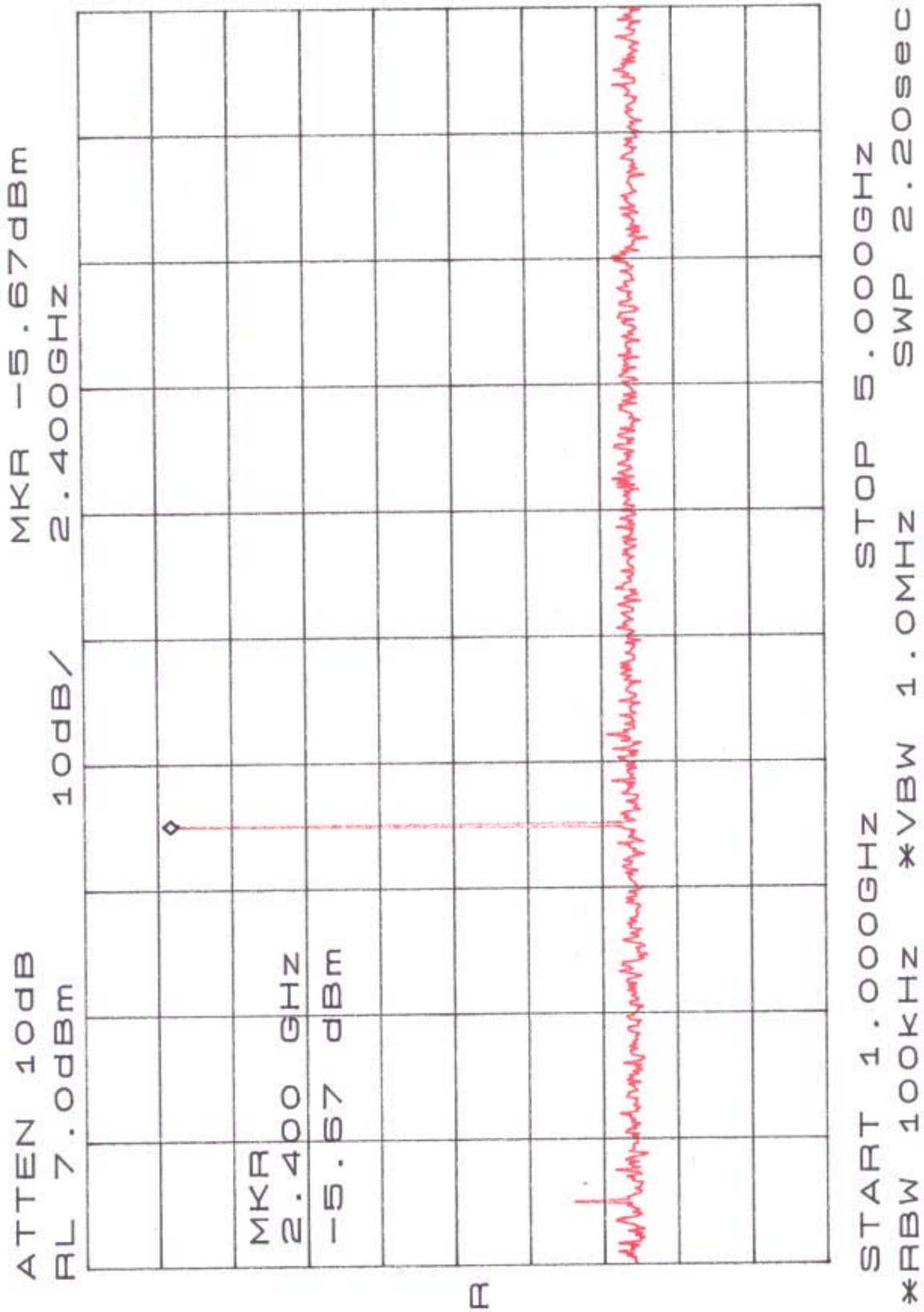
## **Appendix 6 : Plotted Data for 100 kHz Bandwidth from Band Edge**

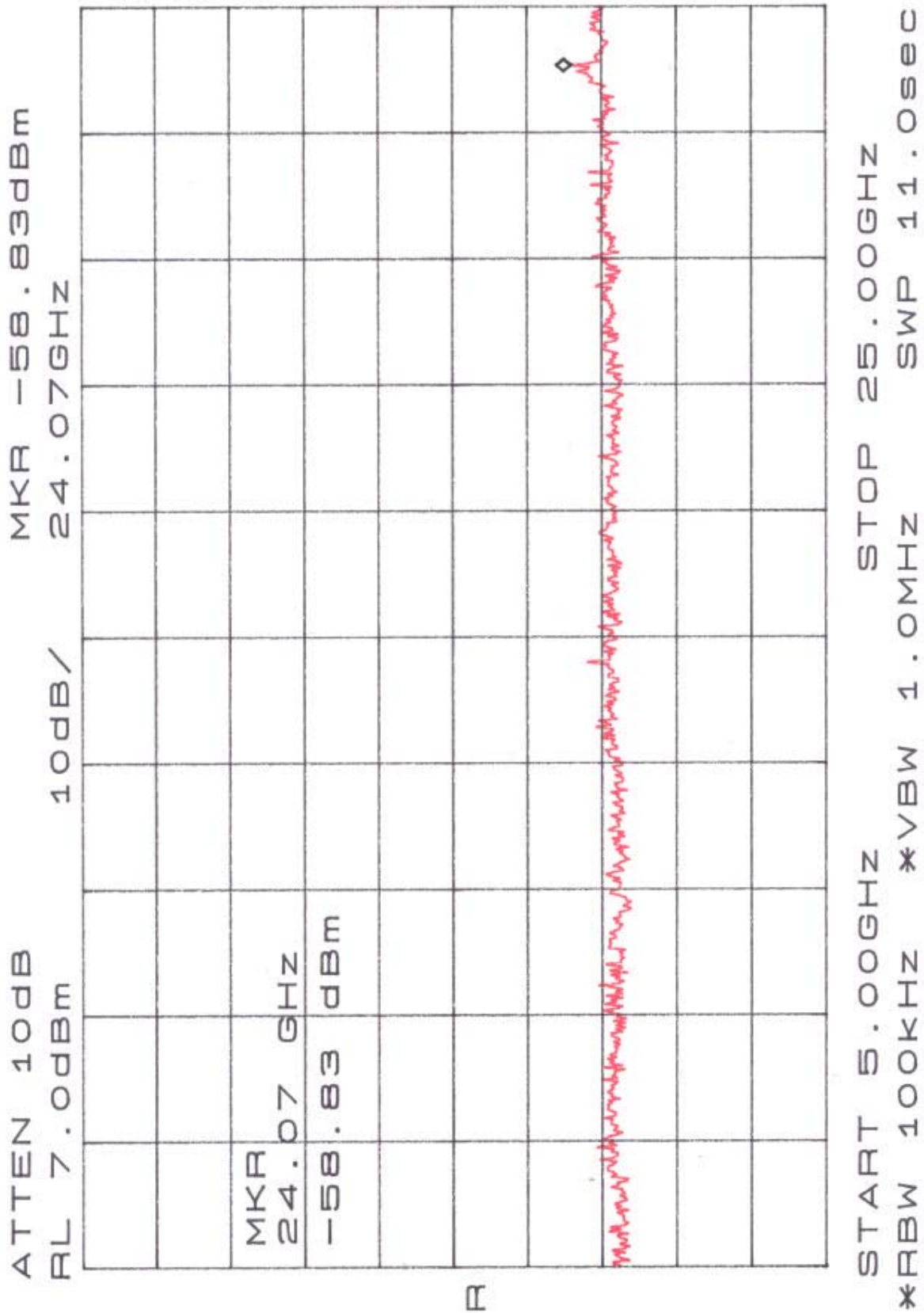




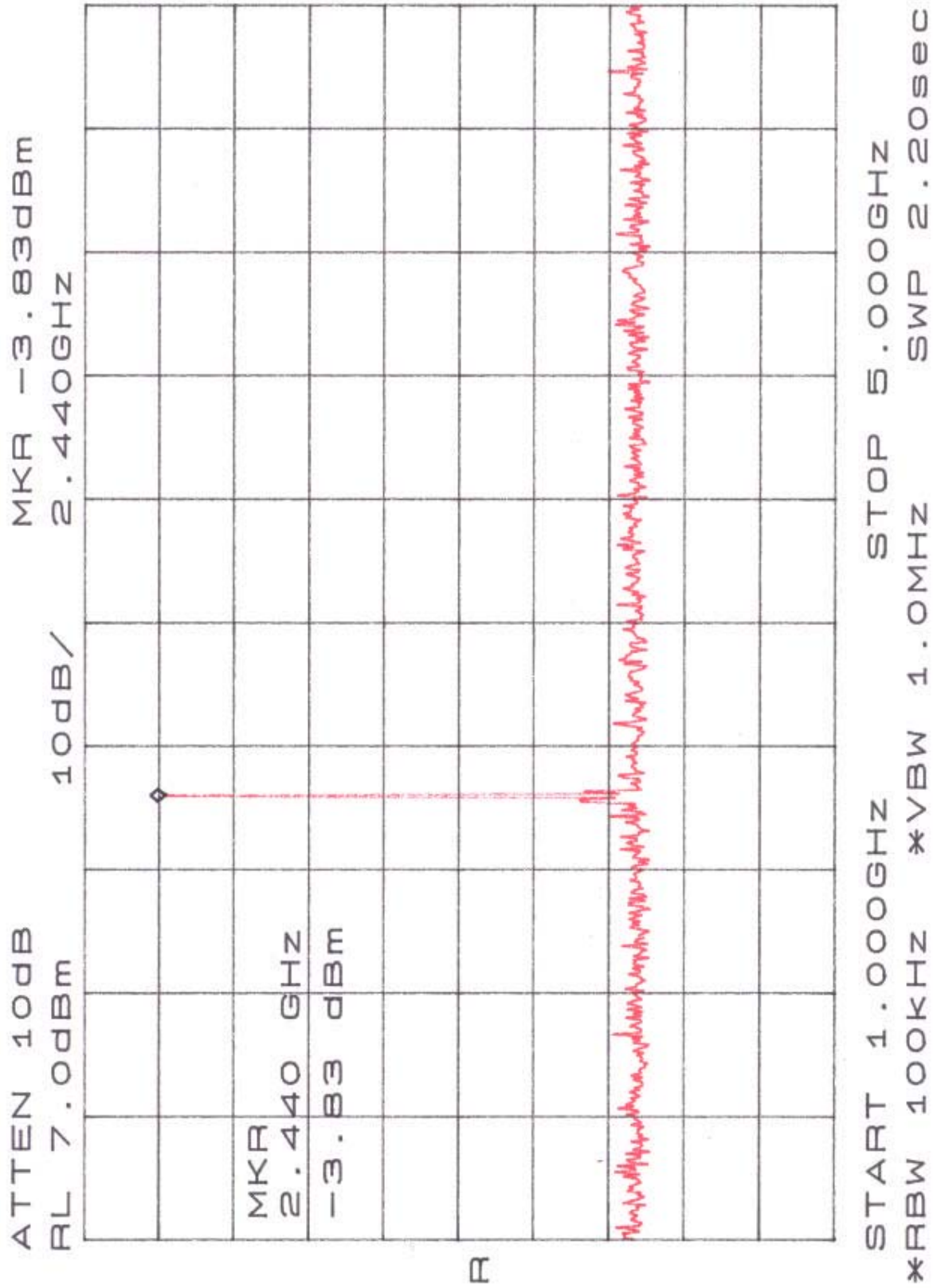


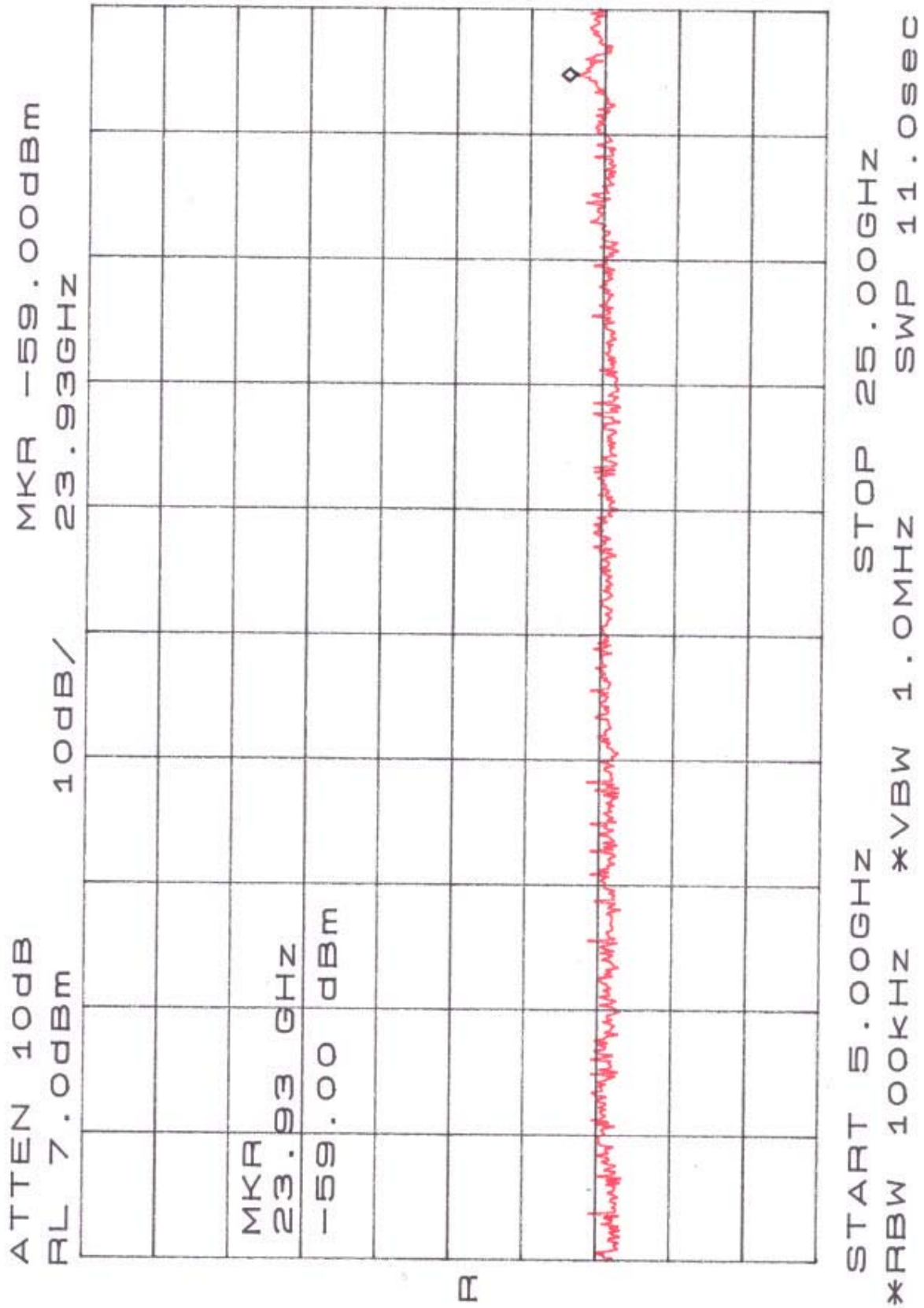
## **Appendix 7 : Plotted Data for Out-of-Band Conducted Emission**

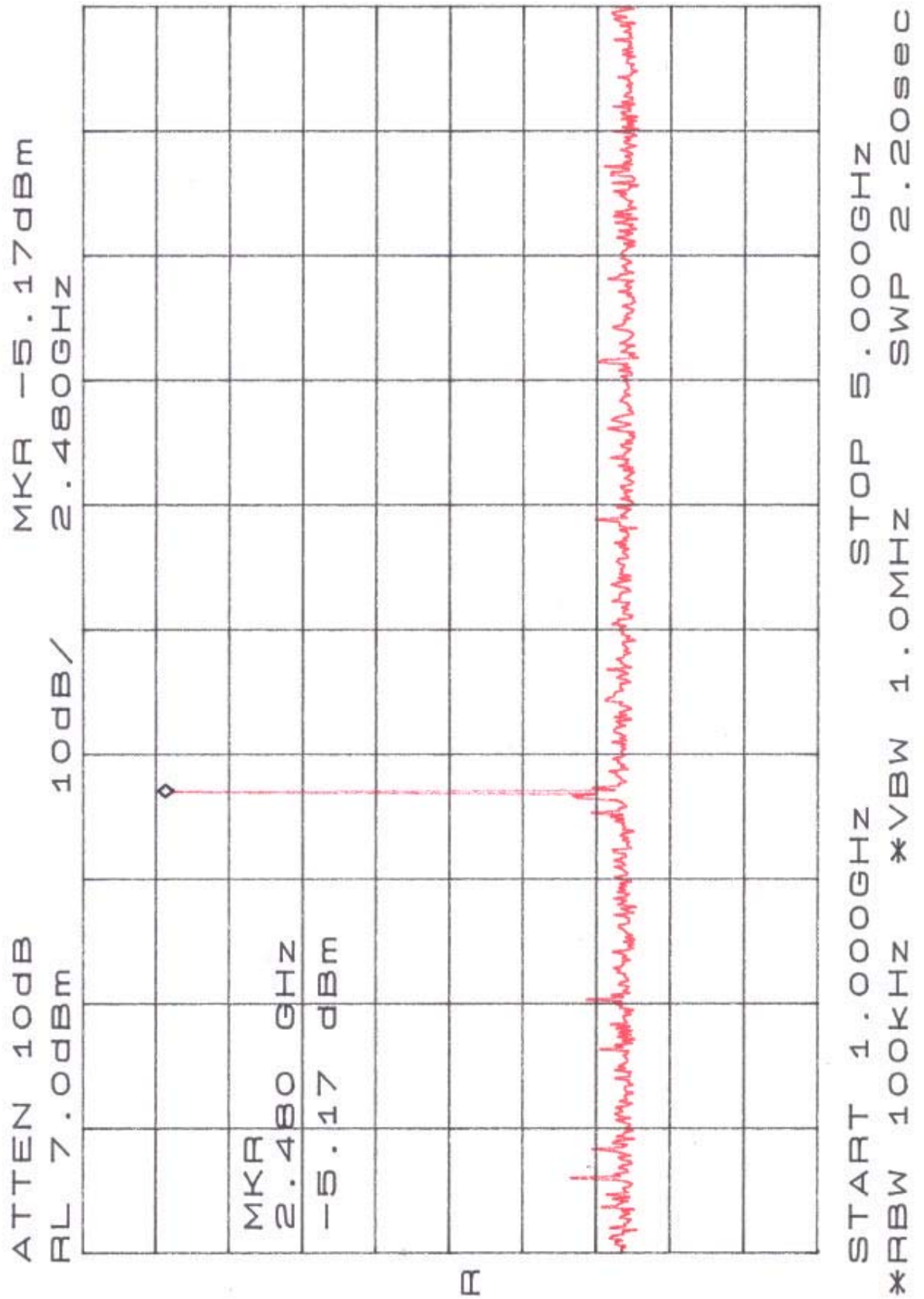




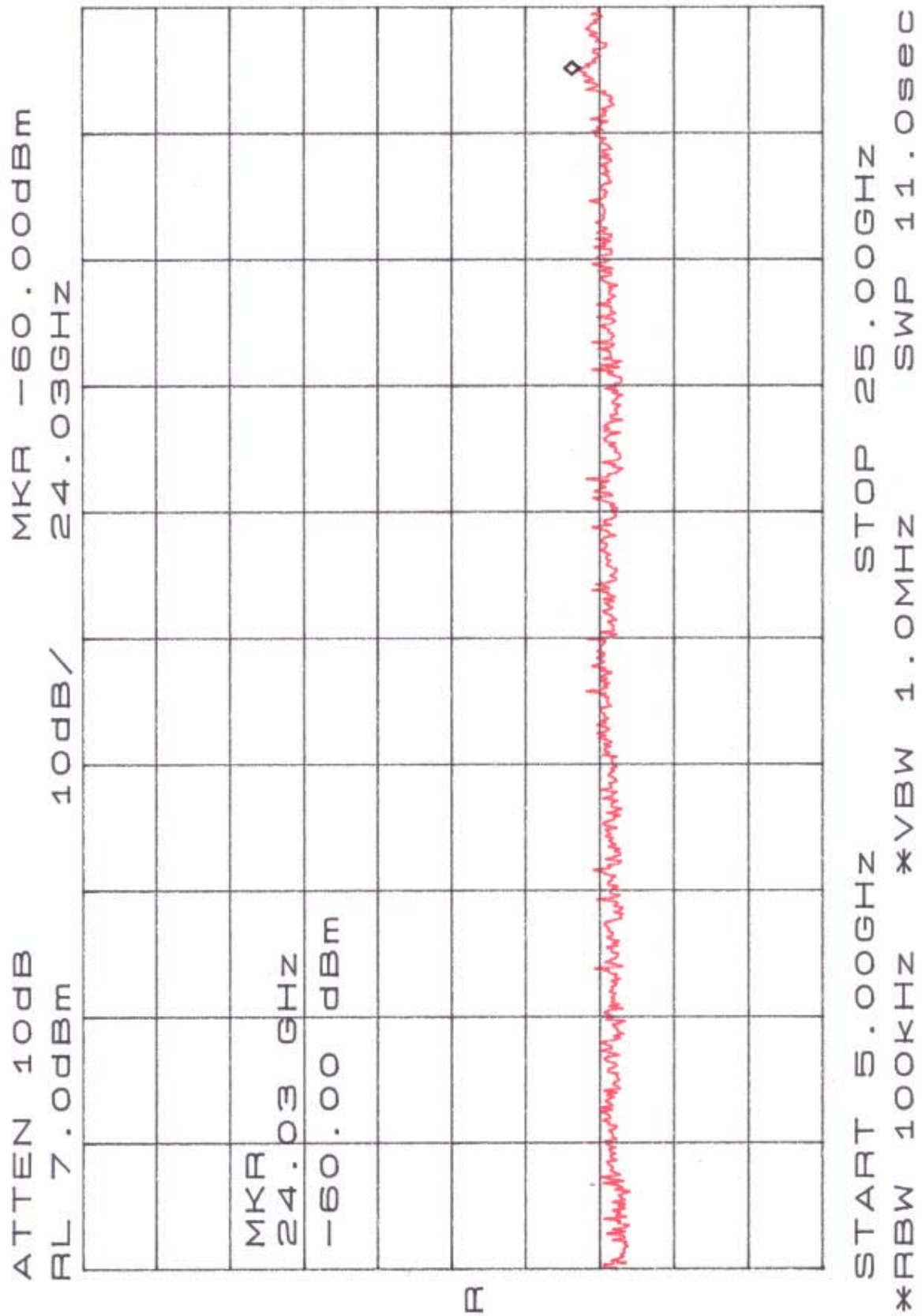












## **Appendix 8 : Plotted Data for Peak Power Spectral Density**

